HIGH SPEED QUAD CHANNEL DIGITAL ISOLATORS

DCL54xx01A

DCL540C01A/DCL540D01A/DCL541A01A/DCL541B01A/
DCL540L01A/DCL540H01A/DCL541L01A/DCL541H01A/DCL542L01A/DCL542H01A

1. Applications

- Industrial automation systems
- Motor control
- Inverter
- Switching power supply

2. Description

DCL540C01A/DCL540D01A/DCL541A01A/DCL541B01A/DCL540L01A/DCL540H01A/DCL541L01A/DCL541H01A/DCL542L01A/DCL542H01A are high-speed quad-channel digital isolators. Outstanding performance characteristics are achieved by Toshiba CMOS technology and the magnetic coupling structure. In addition, they comply with UL 1577 and has a 5000Vrms rating as an isolation voltage. These products can operate with a temperature range of -40 to 125 °C and a wide supply voltage of 2.25 to 5.5 V.

3. Features

Data rate	: Up to 150 Mbps
Supply voltage	: 2.25 V to 5.5 V
Temperature Range	: -40 °C to 125 °C
Propagation Delay	:10.9 ns Typical (5.0 V operation)
Default Output	: High and Low Options
CMTI (Typ.)	: 150 kV/μs
Withstand Voltage	: 5 kVrms
Package	: 16pin SOIC Wide body
Safety-Related Certification	:

UL : UL 1577, File No. E519997

cUL : CSA Component Acceptance Service Notice No. 5A, File No. E519997

VDE : DIN EN IEC 60747-17 (VDE V 0884-17) (Planned) (Note 1)

CQC : (Planned)

Note 1:When a VDE approved type is needed, please contact your Toshiba sales representative.

Start of commercial production
2025-10

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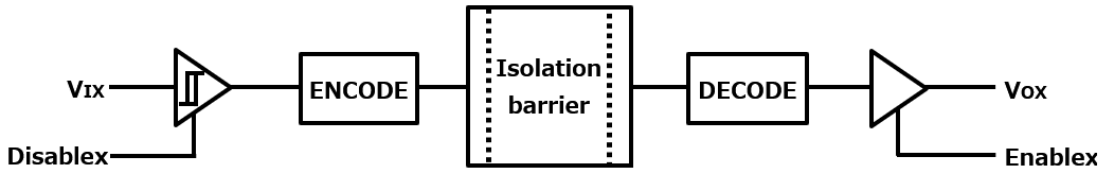
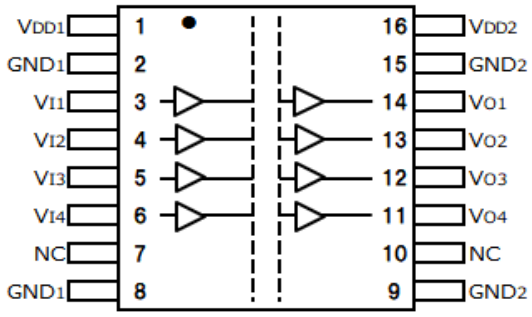
4. Internal Circuit (Simplified Schematic)

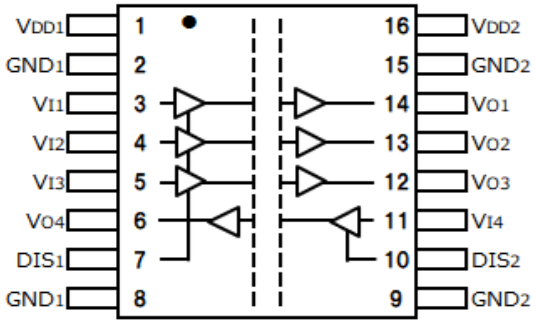


5. Pin configuration and Functions

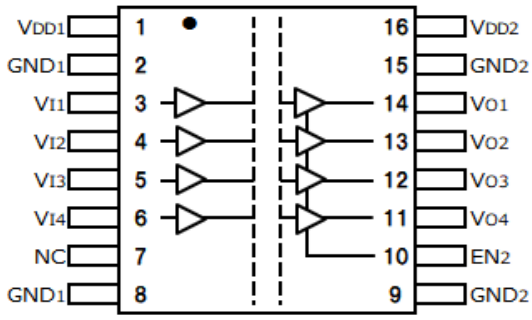
DCL540C01A / DCL540D01A



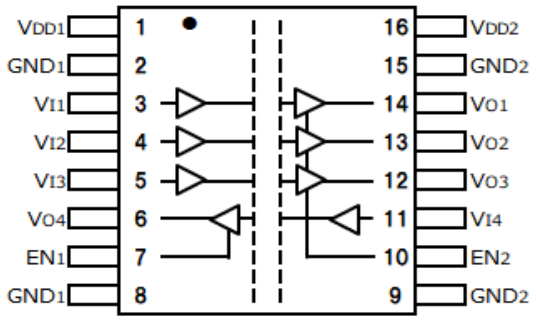
DCL541A01A / DCL541B01A



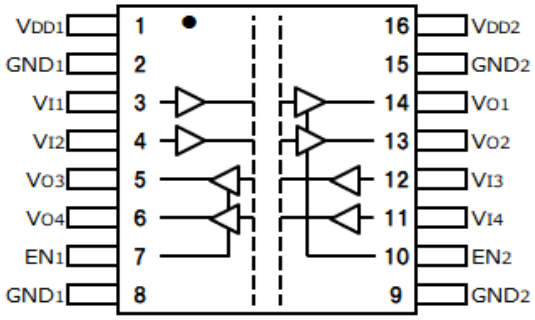
DCL540L01A / DCL540H01A



DCL541L01A / DCL541H01A



DCL542L01A / DCL542H01A



5.1. Pin Functions

PIN						I/O	DESCRIPTION
NAME	DCL540 C01A D01A	DCL540 L01A H01A	DCL541 A01A B01A	DCL541 L01A H01A	DCL542 L01A H01A		
V_{DD1}	1	1	1	1	1	-	Power Supply, side 1
GND_1	2,8	2,8	2,8	2,8	2,8	-	GND connection for V_{DD1} , side 1
V_{I1}	3	3	3	3	3	I	Input, Channel1
V_{I2}	4	4	4	4	4	I	Input, Channel2
V_{I3}	5	5	5	5	12	I	Input, Channel3
V_{I4}	6	11	6	11	11	I	Input, Channel4
NC	7,10	-	7	-	-	-	Non connected
DIS_1	-	7	-	-	-	I	Input disable 1. Input pins on side 1 are disabled when DIS_1 is high, and in enabled state when DIS_1 is low or open.
EN_1	-	-	-	7	7	I	Input enable 1. Input pins on side 1 are enabled when EN_2 is high or open, and in high impedance state when EN_2 is low.
GND_2	9,15	9,15	9,15	9,15	9,15	-	GND connection for V_{DD2}, side 2
DIS_2	-	10	-	-	-	I	Input disable 2. Input pins on side 2 are disabled when DIS_2 is high, and in enabled state when DIS_2 is low or open.
EN_2	-	-	10	10	10	I	Input enable 2. Input pins on side 2 are enabled when EN_2 is high or open, and in high impedance state when EN_2 is low.
V_{O4}	11	6	11	6	6	O	Output, Channel4
V_{O3}	12	12	12	12	5	O	Output, Channel3
V_{O2}	13	13	13	13	13	O	Output, Channel2
V_{O1}	14	14	14	14	14	O	Output, Channel1
V_{DD2}	16	16	16	16	16	-	Power Supply, side 2

6. Functional Description

(1) DCL540C01A/ DCL540D01A

V_{DD1}	V_{DD2}	INPUT (V_{ix})	OUTPUT (V_{Ox})	COMMENTS
PU	PU	L	L	Normal Operation
		H	H	
		OPEN	Default	Default mode DCL540C01A=L , DCL540D01A=H
PD		L or OPEN		
PU	PD	X	Undetermined	When V_{DD2} is unpowered, a channel output is undetermined.
PD		L or OPEN		
PD	X	H	-	Don't use, since a certain voltage will be output through the internal ESD circuit.

PU= Powered up (V_{DD}≥2.25 V), PD= Powered down (V_{DD}≤1.7 V), H= High level, L= Low level, X= Don't care

(2) DCL540L01A/ DCL540H01A/ DCL541L01A/ DCL541H01A/ DCL542L01A/ DCL542H01A

V_{DD1}	V_{DD2}	OUTPUT ENABLE (EN_2)	INPUT (V_{Ix})	OUTPUT (V_{Ox})	COMMENTS
PU	PU	H or OPEN	L	L	Normal Operation
			H	H	
			OPEN	Default	Default mode DCL540L01A=L , DCL540H01A=H
		L	X	Z	Output Disable mode
PD	PU	H or OPEN	L or OPEN	Default	Default mode DCL540L01A=L , DCL540H01A=H
		L		Z	Output Disable mode
	X	X	H	-	Don't use, since a certain voltage will be output through the internal ESD circuit.
PU	PD	L or OPEN	X	Undetermined	When V_{DD2} is unpowered, a channel output is undetermined.
PD			L or OPEN		
X		H	X	-	Don't use, since a certain voltage will be output through the internal ESD circuit.

PU= Powered up (V_{DD}≥2.25 V), PD= Powered down (V_{DD}≤1.7 V), H= High level, L= Low level, X= Don't care

(3) DCL541A01A/ DCL541B01A

V_{DD1}	V_{DD2}	INPUT DISABLE (DIS_x)	INPUT (V_{Ix})	OUTPUT (V_{Ox})	COMMENTS
PU	PU	L or OPEN	L	L	Normal Operation
			H	H	
			OPEN	Default	Default mode DCL541A01A=L , DCL541B01A=H
		H	X		Input Disable mode DCL541A01A=L , DCL541B01A=H
	PD	X	X	Undetermined	When V_{DD2} is unpowered, a channel output is undetermined.
PD	X	H	X	Don't use	Don’t use, since a certain voltage will be output through the internal ESD circuit.
		X	H		
	PU	L or OPEN	L or OPEN	Default	Default mode DCL541A01A=L , DCL541B01A=H
	PD			Undetermined	When V_{DD2} is unpowered, a channel output is undetermined.

V_{DDI}: Input V_{DDx} , V_{DDO}: Output V_{DDx} , PU= Powered up (V_{DD}≥2.25 V), PD=Powered down (V_{DD}≤1.7 V),
H=High Level, L=Low Level, X= Don’t care

7. Absolute Maximum Ratings (T_a = 25 °C)

PARAMETER	SYMBOL	MIN	MAX	UNIT
Power supply voltage	V_{DD1}, V_{DD2}	-0.5	6.0	V
Input Voltage	V_I	-0.5	V_{DDX}+0.5 (Note1)	V
Output Voltage	V_O	-0.5	V_{DDX}+0.5 (Note1)	V
Output Current	I_O	-15	15	mA
Storage Temperature	T_{stg}	-65	150	°C
Operating Temperature	T_{opr}	-40	125	°C
Soldering Temperature (10 s)	T_{sol}	-	260	°C
Maximum Withstanding Isolation Voltage (1 min.)	BV_S	-	5000	Vrms

Note 1: Maximum voltage must not exceed 6 V. X = 1 or 2.

8. Recommended Operating Conditions (Note)

PARAMETER	SYMBOL	MIN	MAX	UNIT
Power supply voltage	V_{DD1}, V_{DD2}	2.25	5.5	V
Junction Temperature	T_J	-40	150	°C
Ambient Temperature	T_a	-40	125	°C

Note: The recommended operating conditions are given as a design guide necessary to obtain the intended performance of the device. Each parameter is an independent value. When creating a system design using this device, the electrical characteristics specified in this data sheet should also be considered.

Note: A ceramic capacitor (0.1 μF) should be connected between pin 1 (V_{DD1}) and pin 2 (GND_1) for V_{DD1} and between pin 16 (V_{DD2}) and pin 15 (GND2) for V_{DD2}, and should be the layout on the IC as close as possible (less than 10 mm).
Otherwise, the IC may not switch properly.

9. Electrical Characteristics

9.1. Electrical Characteristics – 5 V Supply

All typical specifications are at T_a=25 °C, V_{DD1}=V_{DD2}=5 V. Minimum/maximum specifications apply over the entire recommended operating range of 4.5 V≤V_{DD1}≤5.5 V, 4.5 V≤V_{DD2}≤5.5 V, and -40 °C≤T_a≤125 °C, unless otherwise noted.

PARAMETER	TEST CONDITIONS	Fig.	SYMBOL	MIN	TYP.	MAX	UNIT
DC SPECIFICATIONS							
Under voltage Lockout	Threshold when supply voltage is rising	12.1	V_{DDxUV+}	-	2.1	2.25	V
	Threshold when supply voltage is falling		V_{DDxUV-}	1.7	1.9	-	
	Supply voltage hysteresis		V_{DDxUVH}	0.1	0.2	-	
Output Voltage Logic High	V_{Ix}=H , I_{OH}=-20 μA	12.2	V_{OH}	V_{DDO}-0.1 (Note1)	V_{DDO} (Note1)	-	V
	V_{Ix}=H , I_{OH}=-4 mA			V_{DDO}-0.4 (Note1)	V_{DDO}-0.2 (Note1)	-	
Output Voltage Logic Low	V_{Ix}=L , I_{OL} =20 μA	12.2	V_{OL}	-	0.0	0.1	V
	V_{Ix}=L , I_{OL} =4 mA			-	0.2	0.4	
Output impedance	-	12.2	Z_O	-	50	-	Ω
High-level input voltage	-	12.3	V_{IH}	0.7*V_{DDI} (Note1)	-	-	V
Low-level input voltage	-	12.3	V_{IL}	-	-	0.3*V_{DDI} (Note1)	V
Input Voltage Hysteresis	-	12.3	V_{HYS}	-	0.37	-	V
Input Current	V_I= V_{DDI} or 0 V (Note1)	-	I_I	-	-	±10	μA
SWITCHING SPECIFICATIONS							
Data Rate	-	-	t_{bps}	DC	-	150	Mbps
Pulse Width	-	-	PW	6.6	-	-	ns
Propagation Delay	50 kHz,Duty=50 %, t_r=t_f=2 ns,C_L=15 pF	12.4	t_{pHL} , t_{pLH}	-	10.9	18.3	ns
Pulse Width Distortion	|t_{PHL} – t_{PLH}|	12.4	PWD	-	0.8	2.8	ns
Propagation Delay Skew (Between any two units)	(Note 2)	-	t_{PSK}	-	-	10	ns
Channel Matching	Same Direction	12.4	t_{skCD}	-	-	3.2	ns
	Opposing Direction	12.4	t_{skOD}	-	-	3.6	
Output Rise Time	10 % - 90 %	12.4	t_r	-	0.9	-	ns
Output Fall Time	90 % - 10 %	12.4	t_f	-	0.9	-	ns
Enable 3-state output enable time	50 kHz, Duty=50 %, tr=tf=2 ns,CL=15 pF (Note 3)	12.5	t_{pZL} , t_{pZH}	-	-	15.0	ns
Enable 3-state output disable time		12.5	t_{pLZ} , t_{pHZ}	-	-	18.0	ns
Disable output enable time	50 kHz, Duty=50 %, tr=tf=2 ns,CL=15 pF	12.6	t_{p_EN} ,	-	-	23.0	ns
Disable output disable time		12.6	t_{p_DIS}	-	-	23.0	ns
Common mode transient immunity	V_I= V_{DDI} or 0 V, (Note1) V_{CM}=1500 V, Ta=25 °C	12.7	| CMTI |	-	150	-	kV/μs

Note 1: V_{DDI}=Input-side V_{DDx} , V_{DDO}=Output-side V_{DDx}
Note 2: Propagation delay difference (between parts) is applied under the same operating conditions (power supply voltage. input current, temperature conditions, etc.).
Note 3: When EN_2 signal is changed from Low to High or OPEN, the output signal(V_{Ox}) is valid after the output enable time. The output signal(V_{Ox}) within the output enable time is undefined.

9.2. Electrical Characteristics – 3.3 V Supply

All typical specifications are at T_a=25 °C, V_{DD1}=V_{DD2}=3.3 V. Minimum/maximum specifications apply over the entire recommended operating range of 3.0 V≤V_{DD1}≤3.6 V, 3.0 V≤V_{DD2}≤3.6 V, and -40 °C≤T_a≤125 °C, unless otherwise noted.

PARAMETER	TEST CONDITIONS	Fig.	SYMBOL	MIN	TYP.	MAX	UNIT
DC SPECIFICATIONS							
Under voltage Lockout	Threshold when supply voltage is rising	12.1	V_{DDxUV+}	-	2.1	2.25	V
	Threshold when supply voltage is falling		V_{DDxUV-}	1.7	1.9	-	
	Supply voltage hysteresis		V_{DDxUVH}	0.1	0.2	-	
Output Voltage Logic High	V_{Ix}=H , I_{OH}=-20 μA	12.2	V_{OH}	V_{DDO}-0.1 (Note1)	V_{DDO} (Note1)	-	V
	V_{Ix}=H , I_{OH}=-4 mA			V_{DDO}-0.4 (Note1)	V_{DDO}-0.2 (Note1)	-	
Output Voltage Logic Low	V_{Ix}=L , I_{OL} =20 μA	12.2	V_{OL}	-	0.0	0.1	V
	V_{Ix}=L , I_{OL} =4 mA			-	0.2	0.4	
Output impedance	-	12.2	Z_O	-	50	-	Ω
High-level input voltage	-	12.3	V_{IH}	0.7*V_{DDI} (Note1)	-	-	V
Low-level input voltage	-	12.3	V_{IL}	-	-	0.3*V_{DDI} (Note1)	V
Input Voltage Hysteresis	-	12.3	V_{HYS}	-	0.32	-	V
Input Current	V_I= V_{DDI} or 0 V (Note1)	-	I_I	-	-	±10	μA
SWITCHING SPECIFICATIONS							
Data Rate	-	-	t_{bps}	DC	-	150	Mbps
Pulse Width	-	-	PW	6.6	-	-	ns
Propagation Delay	50 kHz,Duty=50 %, t_r=t_f=2 ns,C_L=15 pF	12.4	t_{pHL} , t_{pLH}	-	11.6	19.1	ns
Pulse Width Distortion	|t_{PHL} – t_{PLH}|	12.4	PWD	-	0.8	2.8	ns
Propagation Delay Skew (Between any two units)	(Note 2)	-	t_{PSK}	-	-	10	ns
Channel Matching	Same Direction	12.4	t_{skCD}	-	-	3.3	ns
	Opposing Direction	12.4	t_{skOD}	-	-	3.7	
Output Rise Time	10 % - 90 %	12.4	t_r	-	0.8	-	ns
Output Fall Time	90 % - 10 %	12.4	t_f	-	0.8	-	ns
Enable 3-state output enable time	50 kHz, Duty=50 %, tr=tf=2 ns,CL=15 pF (Note 3)	12.5	t_{pZL} , t_{pZH}	-	-	15.0	ns
Enable 3-state output disable time		12.5	t_{pLZ} , t_{pHZ}	-	-	18.0	ns
Disable output enable time	50 kHz, Duty=50 %, tr=tf=2 ns,CL=15 pF	12.6	t_{p_EN} ,	-	-	23.0	ns
Disable output disable time		12.6	t_{p_DIS}	-	-	23.0	ns
Common mode transient immunity	V_I= V_{DDI} or 0 V, (Note1) V_{CM}=1500 V, Ta=25 °C	12.7	| CMTI |	-	150	-	kV/μs

Note 1: V_{DDI}=Input-side V_{DDx} , V_{DDO}=Output-side V_{DDx}
Note 2: Propagation delay difference (between parts) is applied under the same operating conditions (power supply voltage. input current, temperature conditions, etc.).
Note 3: When EN_2 signal is changed from Low to High or OPEN, the output signal(V_{Ox}) is valid after the output enable time. The output signal(V_{Ox}) within the output enable time is undefined)

9.3. Electrical Characteristics – 2.5 V Supply

All typical specifications are at T_a=25 °C, V_{DD1}=V_{DD2}=2.5 V. Minimum/maximum specifications apply over the entire recommended operating range of 2.25 V≤V_{DD1}≤2.75 V, 2.25 V≤V_{DD2}≤2.75 V, and -40 °C≤T_a≤125 °C, unless otherwise noted.

PARAMETER	TEST CONDITIONS	Fig.	SYMBOL	MIN	TYP.	MAX	UNIT
DC SPECIFICATIONS							
Under voltage Lockout	Threshold when supply voltage is rising	12.1	V_{DDxUV+}	-	2.1	2.25	V
	Threshold when supply voltage is falling		V_{DDxUV-}	1.7	1.9	-	
	Supply voltage hysteresis		V_{DDxUVH}	0.1	0.2	-	
Output Voltage Logic High	V_{Ix}=H , I_{OH}=-20 μA	12.2	V_{OH}	V_{DDO}-0.1 (Note1)	V_{DDO} (Note1)	-	V
	V_{Ix}=H , I_{OH}=-4 mA			V_{DDO}-0.4 (Note1)	V_{DDO}-0.2 (Note1)	-	
Output Voltage Logic Low	V_{Ix}=L , I_{OL} =20 μA	12.2	V_{OL}	-	0.0	0.1	V
	V_{Ix}=L , I_{OL} =4 mA			-	0.2	0.4	
Output impedance	-	12.2	Z_O	-	50	-	Ω
High-level input voltage	-	12.3	V_{IH}	0.7*V_{DDI} (Note1)	-	-	V
Low-level input voltage	-	12.3	V_{IL}	-	-	0.3*V_{DDI} (Note1)	V
Input Voltage Hysteresis	-	12.3	V_{HYS}	-	0.32	-	V
Input Current	V_I= V_{DDI} or 0 V (Note1)	-	I_I	-	-	±10	μA
SWITCHING SPECIFICATIONS							
Data Rate	-	-	t_{bps}	DC	-	150	Mbps
Pulse Width	-	-	PW	6.6	-	-	ns
Propagation Delay	50 kHz,Duty=50 %, t_r=t_f=2 ns,C_L=15 pF	12.4	t_{pHL} , t_{pLH}	-	12.6	21.0	ns
Pulse Width Distortion	|t_{PHL} – t_{PLH}|	12.4	PWD	-	1.0	3.0	ns
Propagation Delay Skew (Between any two units)	(Note 2)	-	t_{PSK}	-	-	10	ns
Channel Matching	Same Direction	12.4	t_{skCD}	-	-	3.5	ns
	Opposing Direction	12.4	t_{skOD}	-	-	3.9	
Output Rise Time	10 % - 90 %	12.4	t_r	-	0.8	-	ns
Output Fall Time	90 % - 10 %	12.4	t_f	-	0.8	-	ns
Enable 3-state output enable time	50 kHz, Duty=50 %, tr=tf=2 ns,CL=15 pF (Note 3)	12.5	t_{pZL} , t_{pZH}	-	-	15.0	ns
Enable 3-state output disable time		12.5	t_{pLZ} , t_{pHZ}	-	-	18.0	ns
Disable output enable time	50 kHz, Duty=50 %, tr=tf=2 ns,CL=15 pF	12.6	t_{p_EN}	-	-	23.0	ns
Disable output disable time		12.6	t_{p_DIS}	-	-	23.0	ns
Common mode transient immunity	V_I= V_{DDI} or 0 V, (Note1) V_{CM}=1500 V, Ta=25 °C	12.7	| CMTI |	-	150	-	kV/μs

Note 1: V_{DDI}=Input-side V_{DDx} , V_{DDO}=Output-side V_{DDx}
Note 2: Propagation delay difference (between parts) is applied under the same operating conditions (power supply voltage. input current, temperature conditions, etc.)..
Note 3: When EN_2 signal is changed from Low to High or OPEN, the output signal(V_{Ox}) is valid after the output enable time. The output signal(V_{Ox}) within the output enable time is undefined)

9.4. Supply Current Characteristics – 5 V Supply

All typical specifications are at T_a=25 °C, V_{DD1}=V_{DD2}=5 V. Minimum/maximum specifications apply over the entire recommended operating range of 4.5 V≤V_{DD1}≤5.5 V, 4.5 V≤V_{DD2}≤5.5 V, and -40 °C≤T_a≤125 °C, unless otherwise noted.

(1) DCL540x01A

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Current (DC Signal)	VI=0(DCL540C01A , DCL540L01A) , VI=1(DCL540D01A , DCL540H01A)	$I_{DD1(Q)}$	-	2.1	3.0	mA
		$I_{DD2(Q)}$	-	5.0	7.3	mA
	VI=0(DCL540D01A , DCL540H01A) , VI=1(DCL540C01A , DCL540L01A)	$I_{DD1(Q)}$	-	19.6	28.1	mA
		$I_{DD2(Q)}$	-	5.3	7.6	mA
1 Mbps	f_{CLK}=500 kHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(1)}$	-	11.2	17.5	mA
		$I_{DD2(1)}$	-	5.4	8.3	mA
25 Mbps	f_{CLK}=12.5 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(25)}$	-	11.0	17.1	mA
		$I_{DD2(25)}$	-	9.8	14.7	mA
100 Mbps	f_{CLK}=50 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(100)}$	-	12.4	18.4	mA
		$I_{DD2(100)}$	-	25.2	37.1	mA

(2) DCL541x01A

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Current (DC Signal)	V_I=0 (DCL541A01A, DCL541L01A) V_I=1 (DCL541B01A, DCL541H01A)	$I_{DD1(Q)}$	-	3.0	4.3	mA
		$I_{DD2(Q)}$	-	4.5	6.6	mA
	V_I=0 (DCL541B01A, DCL541H01A) V_I=1 (DCL541A01A, DCL541L01A)	$I_{DD1(Q)}$	-	16.6	22.5	mA
		$I_{DD2(Q)}$	-	10.2	14.1	mA
1 Mbps	f_{CLK}=500 kHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(1)}$	-	10.0	15.5	mA
		$I_{DD2(1)}$	-	7.6	10.2	mA
25 Mbps	f_{CLK}=12.5 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(25)}$	-	12.1	18.2	mA
		$I_{DD2(25)}$	-	10.6	15.4	mA
100 Mbps	f_{CLK}=50 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(100)}$	-	17.4	24.5	mA
		$I_{DD2(100)}$	-	22.5	35.2	mA

(3) DCL542x01A

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Current (DC Signal)	VI=0(DCL542L01A) , VI=1(DCL542H01A)	$I_{DD1(Q)}$	-	3.8	5.5	mA
		$I_{DD2(Q)}$	-	3.8	5.5	mA
	VI=0(DCL542H01A) , VI=1(DCL542L01A)	$I_{DD1(Q)}$	-	13.4	18.3	mA
		$I_{DD2(Q)}$	-	13.4	18.3	mA
1 Mbps	f_{CLK}=500 kHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(1)}$	-	8.8	12.9	mA
		$I_{DD2(1)}$	-	8.8	12.9	mA
25 Mbps	f_{CLK}=12.5 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(25)}$	-	11.4	16.8	mA
		$I_{DD2(25)}$	-	11.4	16.8	mA
100 Mbps	f_{CLK}=50 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(100)}$	-	20.0	29.9	mA
		$I_{DD2(100)}$	-	20.0	29.9	mA

9.5. Supply Current Characteristics – 3.3 V Supply

All typical specifications are at T_a=25 °C, V_{DD1}=V_{DD2}=3.3 V. Minimum/maximum specifications apply over the entire recommended operating range of 3.0 V≤V_{DD1}≤3.6 V, 3.0 V≤V_{DD2}≤3.6 V, and -40 °C≤T_a≤125 °C, unless otherwise noted.

(1) DCL540x01A

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Current (DC Signal)	VI=0(DCL540C01A , DCL540L01A) , VI=1(DCL540D01A , DCL540H01A)	$I_{DD1(Q)}$	-	2.0	2.9	mA
		$I_{DD2(Q)}$	-	4.9	7.1	mA
	VI=0(DCL540D01A , DCL540H01A) , VI=1(DCL540C01A , DCL540L01A)	$I_{DD1(Q)}$	-	19.4	27.7	mA
		$I_{DD2(Q)}$	-	5.2	7.4	mA
1 Mbps	f_{CLK}=500 kHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(1)}$	-	11.0	16.7	mA
		$I_{DD2(1)}$	-	5.2	7.8	mA
25 Mbps	f_{CLK}=12.5 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(25)}$	-	10.6	16.0	mA
		$I_{DD2(25)}$	-	8.2	12.4	mA
100 Mbps	f_{CLK}=50 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(100)}$	-	11.6	16.6	mA
		$I_{DD2(100)}$	-	16.5	29.3	mA

(2) DCL541x01A

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Current (DC Signal)	V_I=0 (DCL541A01A, DCL541L01A) V_I=1 (DCL541B01A, DCL541H01A)	$I_{DD1(Q)}$	-	2.9	4.1	mA
		$I_{DD2(Q)}$	-	4.4	6.5	mA
	V_I=0 (DCL541B01A, DCL541H01A) V_I=1 (DCL541A01A, DCL541L01A)	$I_{DD1(Q)}$	-	16.5	22.3	mA
		$I_{DD2(Q)}$	-	10.1	14.0	mA
1 Mbps	f_{CLK}=500 kHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(1)}$	-	9.9	14.9	mA
		$I_{DD2(1)}$	-	7.5	9.5	mA
25 Mbps	f_{CLK}=12.5 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(25)}$	-	10.8	16.6	mA
		$I_{DD2(25)}$	-	9.7	12.8	mA
100 Mbps	f_{CLK}=50 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(100)}$	-	14.5	19.9	mA
		$I_{DD2(100)}$	-	16.6	26.0	mA

(3) DCL542x01A

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Current (DC Signal)	V_I=0 (DCL542L01A) V_I=1 (DCL542H01A)	$I_{DD1(Q)}$	-	3.7	5.3	mA
		$I_{DD2(Q)}$	-	3.7	5.3	mA
	V_I=0 (DCL542H01A) V_I=1 (DCL542L01A)	$I_{DD1(Q)}$	-	13.3	18.2	mA
		$I_{DD2(Q)}$	-	13.3	18.2	mA
1 Mbps	f_{CLK}=500 kHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(1)}$	-	8.7	12.2	mA
		$I_{DD2(1)}$	-	8.7	12.2	mA
25 Mbps	f_{CLK}=12.5 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(25)}$	-	10.3	14.7	mA
		$I_{DD2(25)}$	-	10.3	14.7	mA
100 Mbps	f_{CLK}=50 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(100)}$	-	15.6	23.0	mA
		$I_{DD2(100)}$	-	15.6	23.0	mA

9.6. Supply Current Characteristics – 2.5 V Supply

All typical specifications are at T_a=25 °C, V_{DD1}=V_{DD2}=2.5 V. Minimum/maximum specifications apply over the entire recommended operating range of 2.25 V≤V_{DD1}≤2.75 V, 2.25 V≤V_{DD2}≤2.75 V, and -40 °C≤T_a≤125 °C, unless otherwise noted

(1) DCL540x01A

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Current (DC Signal)	VI=0(DCL541A01A) , VI=1(DCL541B01A)	$I_{DD1(Q)}$	-	1.9	2.8	mA
		$I_{DD2(Q)}$	-	4.9	7.0	mA
	VI=0(DCL541B01A) , VI=1(DCL541A01A)	$I_{DD1(Q)}$	-	19.3	27.6	mA
		$I_{DD2(Q)}$	-	5.2	7.3	mA
1 Mbps	f_{CLK}=50 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(1)}$	-	11.0	16.6	mA
		$I_{DD2(1)}$	-	5.2	7.7	mA
25 Mbps	f_{CLK}=500 kHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(25)}$	-	10.4	15.8	mA
		$I_{DD2(25)}$	-	7.5	11.6	mA
100 Mbps	f_{CLK}=12.5 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(100)}$	-	11.5	16.3	mA
		$I_{DD2(100)}$	-	13.6	25.8	mA

(2) DCL541x01A

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Current (DC Signal)	V_I=0 (DCL541A01A, DCL541L01A) V_I=1 (DCL541B01A, DCL541H01A)	$I_{DD1(Q)}$	-	2.9	4.1	mA
		$I_{DD2(Q)}$	-	4.5	6.4	mA
	V_I=0 (DCL541B01A, DCL541H01A) V_I=1 (DCL541A01A, DCL541L01A)	$I_{DD1(Q)}$	-	16.4	22.2	mA
		$I_{DD2(Q)}$	-	10.0	13.9	mA
1 Mbps	f_{CLK}=500 kHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(1)}$	-	9.8	14.8	mA
		$I_{DD2(1)}$	-	7.4	9.5	mA
25 Mbps	f_{CLK}=12.5 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(25)}$	-	10.4	16.1	mA
		$I_{DD2(25)}$	-	9.2	12.2	mA
100 Mbps	f_{CLK}=50 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(100)}$	-	13.1	18.2	mA
		$I_{DD2(100)}$	-	14.3	24.1	mA

(3) DCL542x01A

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Current (DC Signal)	V_I=0 (DCL542L01A) V_I=1 (DCL541H01A)	$I_{DD1(Q)}$	-	3.7	5.3	mA
		$I_{DD2(Q)}$	-	3.7	5.3	mA
	V_I=0 (DCL542H01A) V_I=1 (DCL542L01A)	$I_{DD1(Q)}$	-	13.2	18.1	mA
		$I_{DD2(Q)}$	-	13.2	18.1	mA
1 Mbps	f_{CLK}=500 kHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(1)}$	-	8.6	12.2	mA
		$I_{DD2(1)}$	-	8.6	12.2	mA
25 Mbps	f_{CLK}=12.5 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(25)}$	-	9.8	14.2	mA
		$I_{DD2(25)}$	-	9.8	14.2	mA
100 Mbps	f_{CLK}=50 MHz, duty=50 % cycle square wave. C_L=15 pF	$I_{DD1(100)}$	-	13.7	21.2	mA
		$I_{DD2(100)}$	-	13.7	21.2	mA

10. Insulation Specifications

PARAMETER	Symbol	TEST CONDITIONS	VALUE	UNIT
Minimum External Clearance	CLR	Shortest terminal-to-terminal distance through air	8	mm
Minimum External Creepage	CPG	Shortest terminal-to-terminal distance across the package surface	7.6	mm
Distance Through The Insulation	DTI	Minimum internal gap	17	µm
Comparative Tracking Index	CTI		400	V
Material Group	-	According to IEC 60664-1	II	-
Overvoltage Category Per IEC 60664-1	-	Related Mains Voltage ≤ 300 V_{rms}	I-IV	-
	-	Related Mains Voltage ≤ 600 V_{rms}	I-IV	-
	-	Related Mains Voltage ≤ 1000 V_{rms}	I-III	-
DIN EN IEC 60747-17; (VDE 0884-17)				
Maximum Repetitive Peak Isolation Voltage	V_{IORM}	AC voltage (bipolar)	1414	V_{PK}
Maximum Transient Isolation Voltage	V_{IOTM}	$V_{TEST} = V_{IOTM}$, t = 60 s (qualification) , V_{TEST}= 1.2 x V_{IOTM}, t = 1 s (100 % production)	8000	V_{PK}
Maximum Impulse Voltage	V_{IMP}	IEC 62368-1, 1.2/50 µs waveform	8000	V_{PK}
Maximum surge isolation voltage	V_{IOSM}	Test method per IEC 62368-1, 1.2/50 µs waveform, $V_{IOSM} \geq 1.3 \times V_{IMP}$ (qualification)	12800	V_{PK}
Apparent charge measuring voltage	$V_{pd(m)}$	Method A, After Input/Output safety test subgroup2&3, $V_{ini,a}=V_{IOTM}$, $V_{pd(m)}=1.2 \times V_{IORM}$ t_{ini} = 60 s, t_m = 10 s, partial discharge < 5 pC	1697	V_{PK}
		Method A, After environmental tests subgroup 1, $V_{ini,a}=V_{IOTM}$, $V_{pd(m)}=1.6 \times V_{IORM}$ t_{ini} = 60 s, t_m = 10 s, partial discharge < 5 pC	2263	
		Method B1; At routine test (100 % production) and preconditioning (type test) $V_{ini,b} \geq 1.2 \times V_{IOTM}$, $V_{pd(m)}=1.875 \times V_{IORM}$ $t_{ini,b}$ = 1 s, t_m = 1 s partial discharge < 5 pC	2652	
Barrier capacitance, input to output	C_{IO}	f = 1 MHz	1.5	pF
Input Capacitance	C_I	V_{IX}	1.8	pF
Isolation Resistance	R_{IO}	V_{IO} = 500 V, T_A = 25 °C	$>10^{12}$	Ω
		V_{IO} = 500 V, 100 °C ≤ T_A ≤ 125 °C	$>10^{11}$	
		V_{IO} = 500 V at T_S = 150 °C	$>10^{9}$	
Pollution Degree	-	-	2	-
Climatic Category	-	-	40/125/21	-
UL 1577				
Maximum Withstanding Isolation Voltage	V_{ISO}	$V_{TEST} = V_{ISO}$, t = 60 s (qualification), $V_{TEST} = 1.2 \times V_{ISO}$, t = 1 s (100 % production)	5000	V_{rms}

11. Safety Limiting Values

PARAMETER	Symbol	TEST CONDITIONS	Value	Unit
Safety Input, Output Or Supply Current	I_S	V_{DD1}=V_{DD2}=5.5 V, Tj=150 °C, Ta=25 °C	284	mA
		V_{DD1}=V_{DD2}=3.6 V, Tj=150 °C, Ta=25 °C	434	mA
		V_{DD1}=V_{DD2}=2.75 V, Tj=150 °C, Ta=25 °C	568	mA
Safety Input, Output Or Total Power	P_S	Tj=150 °C, Ta=25 °C	1562	mW
Maximum Safety Temperature	T_S	-	150	°C

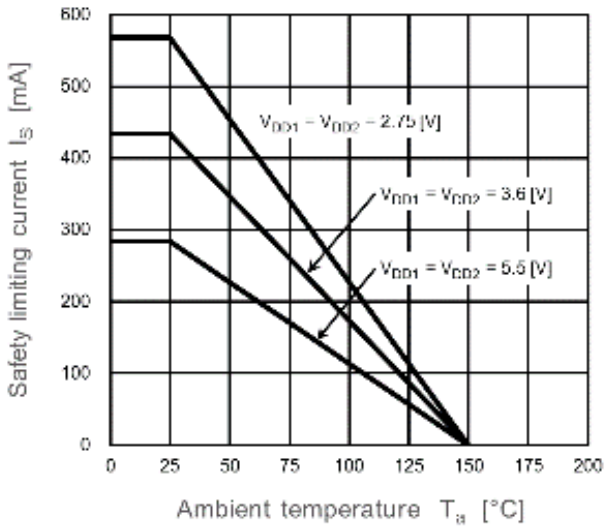
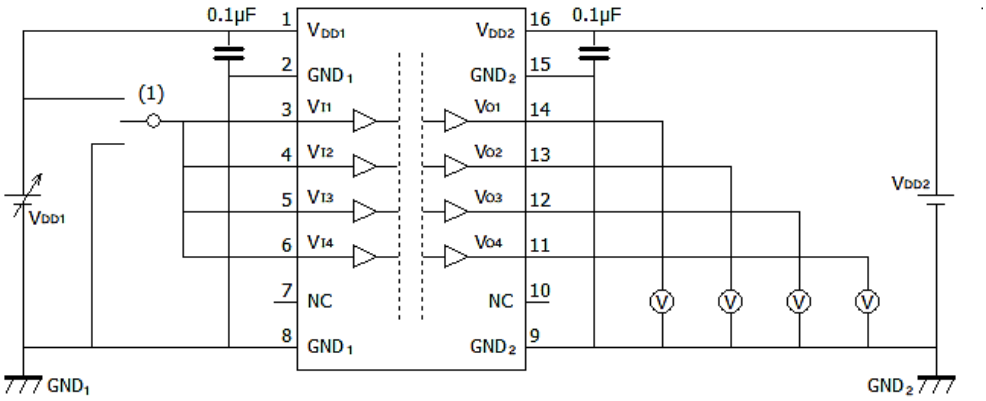


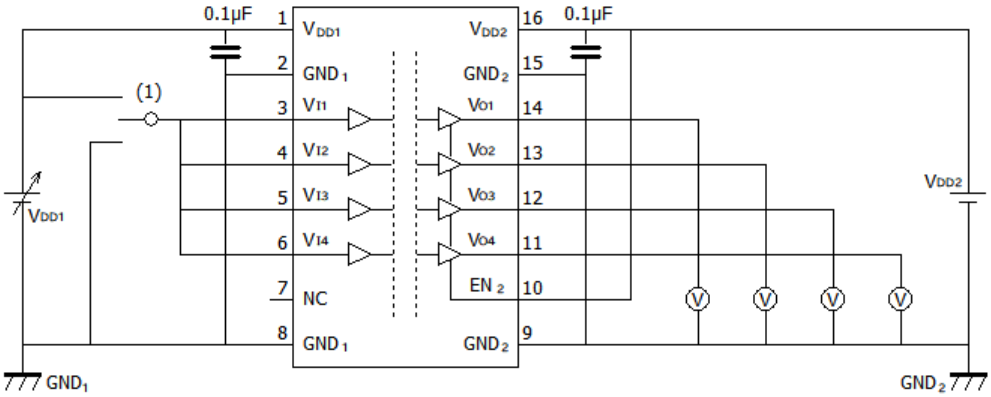
Fig. 11.1. Thermal Derating Curve for Safety Limiting Current - Ta

12. Test Circuit



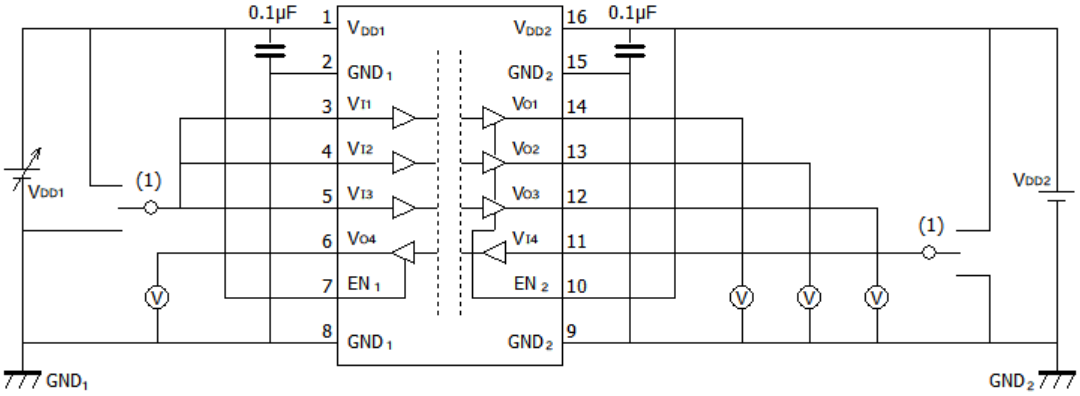
1: Default=L : V_{DD1} , Default=H : GND_1

Fig.12.1.1. DCL540C01A/DCL540D01A V_{DD1UV+}/ V_{DD1UV-}Test Circuit



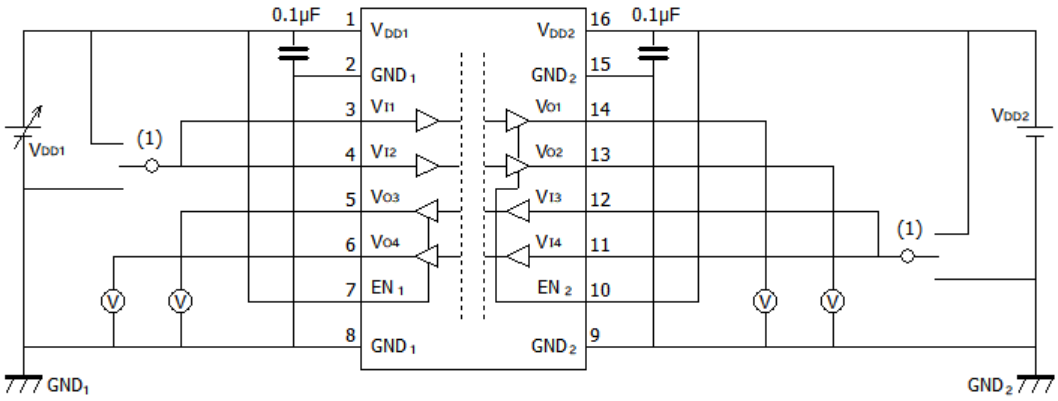
1: Default=L : V_{DD1} , Default=H : GND_1

Fig.12.1.2. DCL540L01A/DCL540H01A V_{DD1UV+}/ V_{DD1UV-}Test Circuit



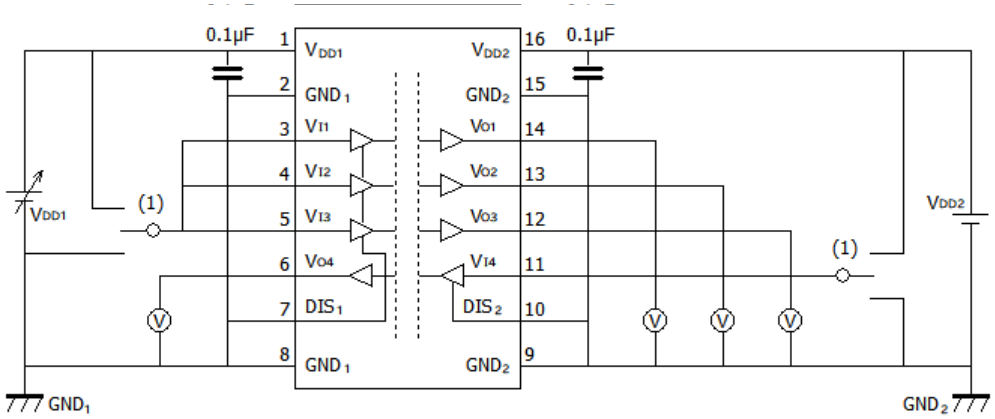
1: Default=L : V_{DD1} , Default=H : GND_1

Fig.12.1.3. DCL541L01A/DCL541H01A V_{DD1UV+}/ V_{DD1UV-}Test Circuit



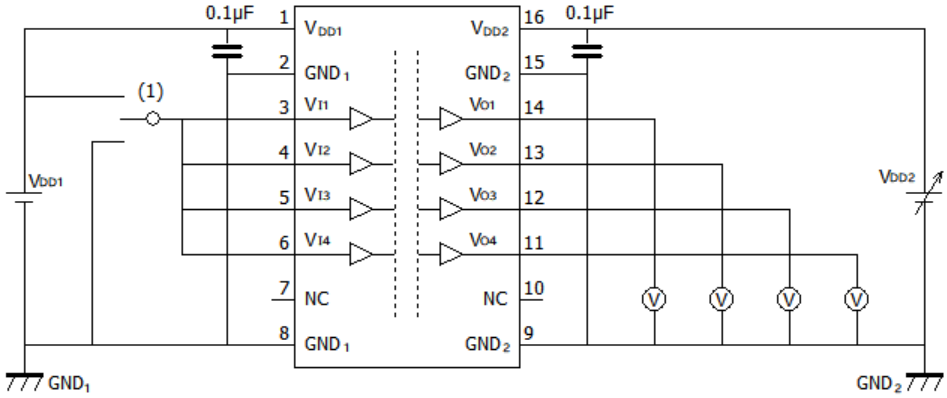
1: Default=L : V_{DD1} , Default=H : GND_1

Fig.12.1.4. DCL542L01A/DCL542H01A V_{DD1UV+}/ V_{DD1UV-}Test Circuit



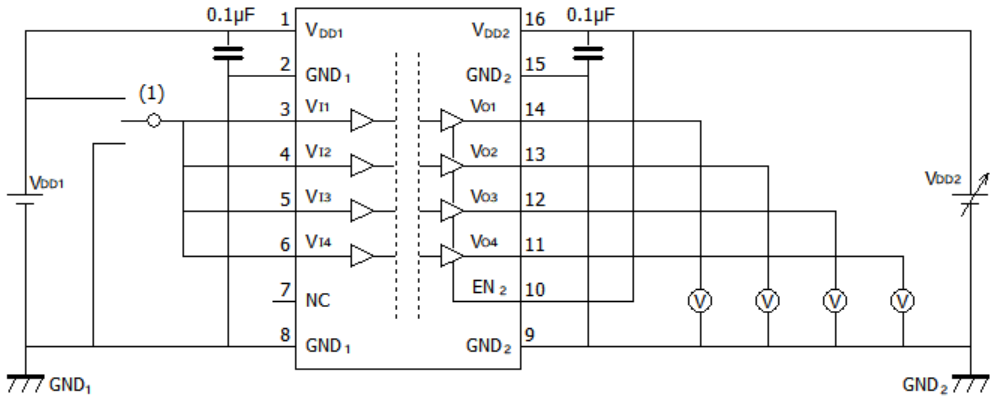
1: Default=L : V_{DD1} , Default=H : GND_1

Fig.12.1.5. DCL541A01A/DCL541V01 V_{DD1UV+}/ V_{DD1UV-}Test Circuit



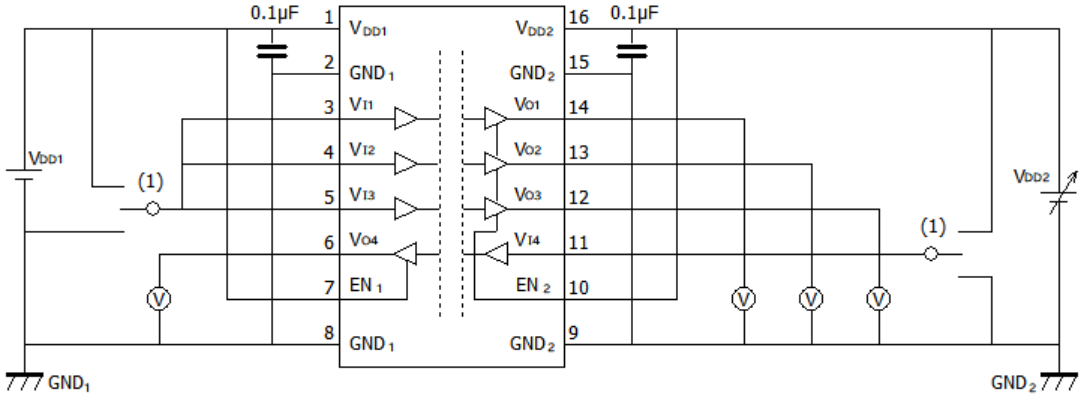
1: Default=L : V_{DD1} , Default=H : GND_1

Fig.12.1.6. DCL540C01A/DCL540D01A V_{DD2UV+}/ V_{DD2UV-}Test Circuit



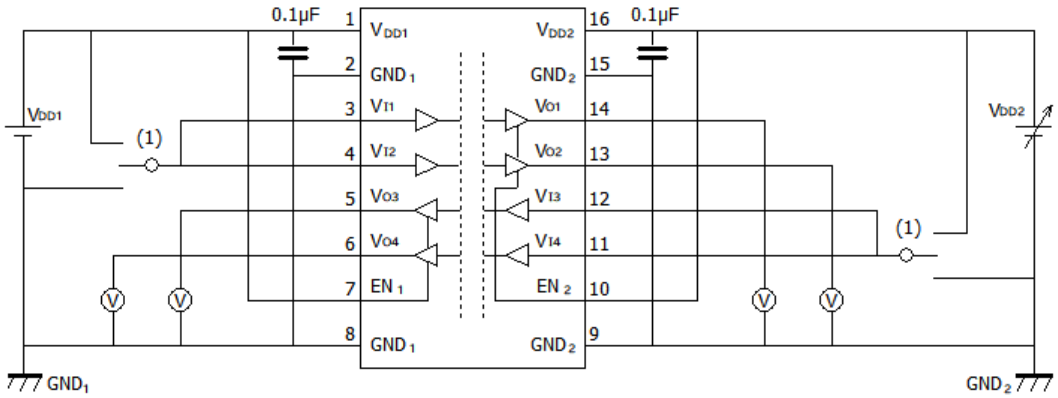
1: Default=L : V_{DD1} , Default=H : GND_1

Fig.12.1.7. DCL540L01A/DCL540H01A V_{DD2UV+}/ V_{DD2UV-}Test Circuit



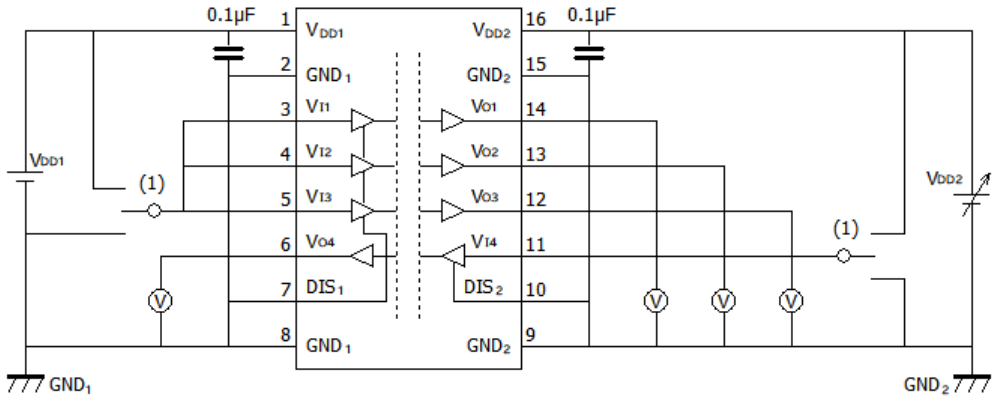
1: Default=L : V_{DDx} , Default=H : GNDx

Fig.12.1.8. DCL541L01A/DCL541H01A V_{DD2UV+}/ V_{DD2UV-}Test Circuit



1: Default=L : V_{DDx} , Default=H : GNDx

Fig.12.1.9. DCL542L01A/DCL542H01A V_{DD2UV+}/ V_{DD2UV-}Test Circuit



1: Default=L : V_{DDx} , Default=H : GNDx

Fig.12.1.10. DCL541A01A/DCL541B01A V_{DD2UV+}/ V_{DD2UV-}Test Circuit

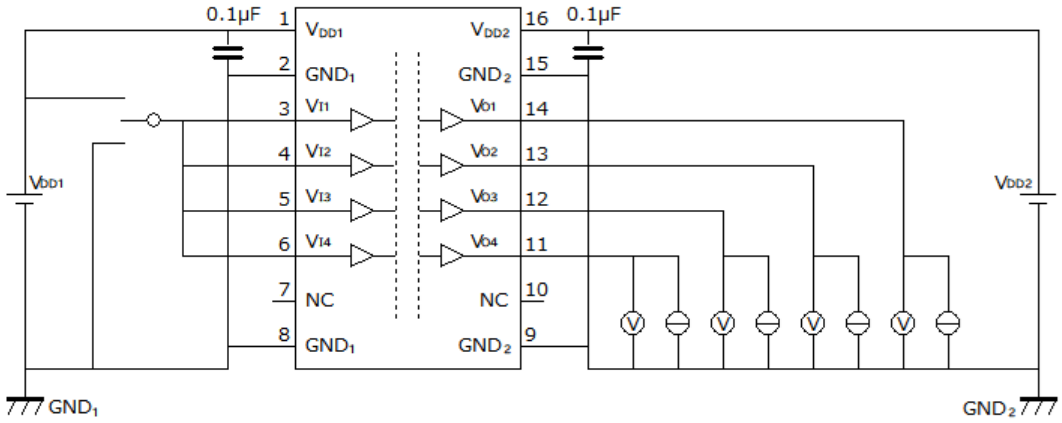


Fig.12.2.1. DCL540C01A/DCL540D01A V_{OH}/V_{OL} Test Circuit

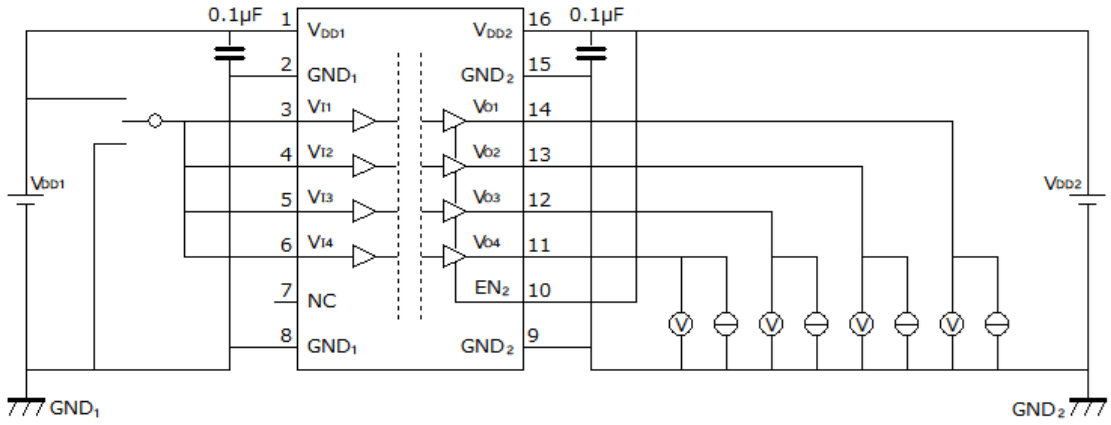


Fig.12.2.2. DCL540L01A/DCL540H01A V_{OH}/V_{OL} Test Circuit

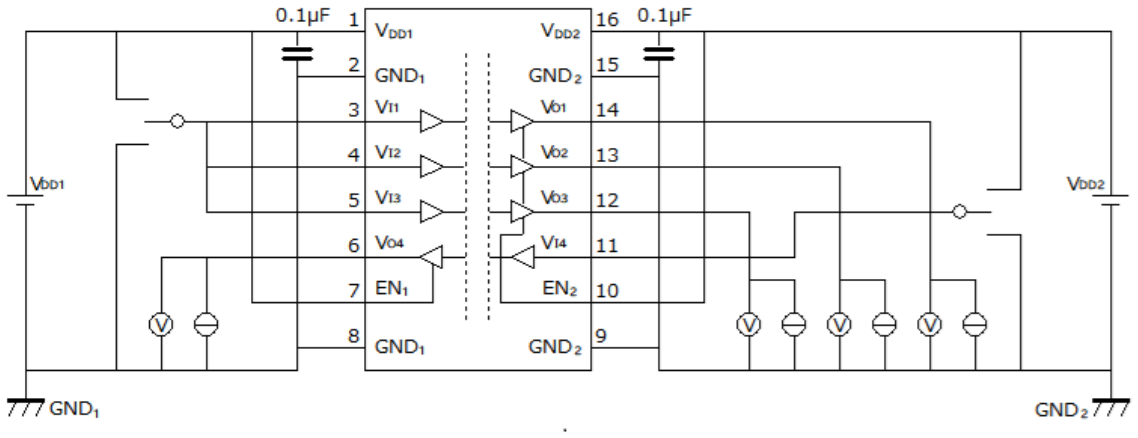


Fig.12.2.3. DCL541L01A/DCL541H01A V_{OH}/V_{OL} Test Circuit

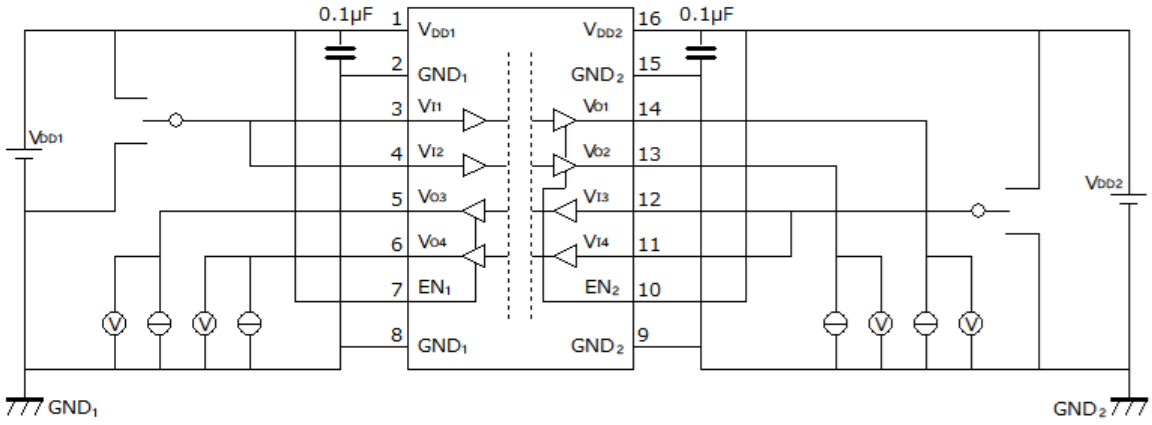


Fig.12.2.4. DCL542L01A/DCL542H01A V_{OH}/V_{OL} Test Circuit

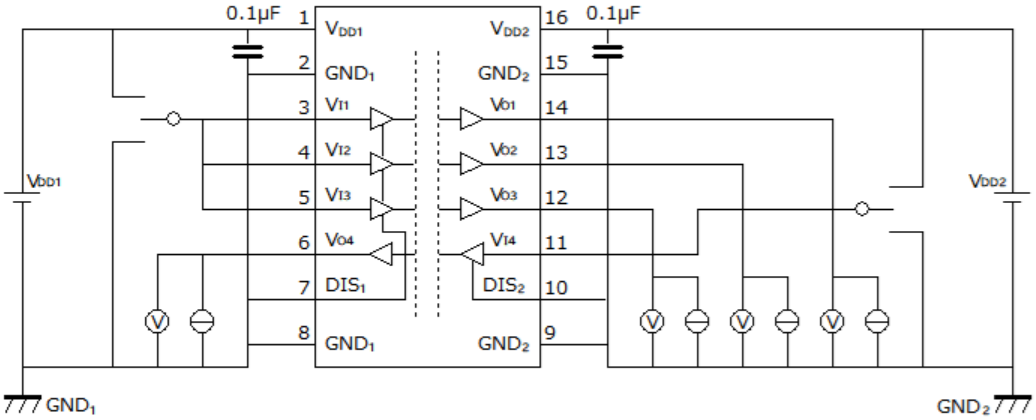


Fig.12.2.5. DCL541A01A/DCL541B01A V_{OH}/V_{OL} Test Circuit

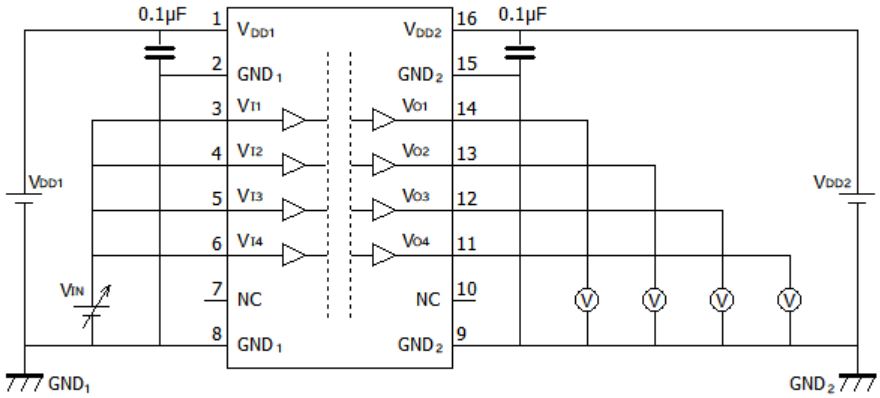


Fig.12.3.1. DCL540C01A/DCL540D01A V_{IH}/V_{IL} Test Circuit

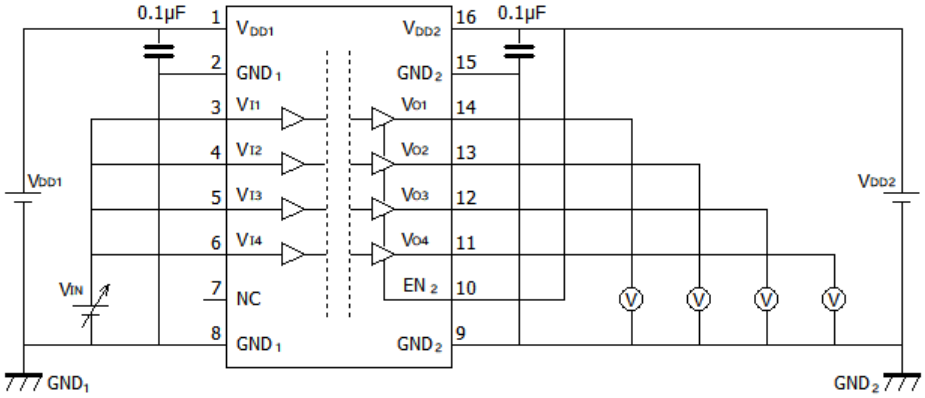


Fig.12.3.2. DCL540L01A/DCL540H01A V_{IH}/V_{IL} Test Circuit

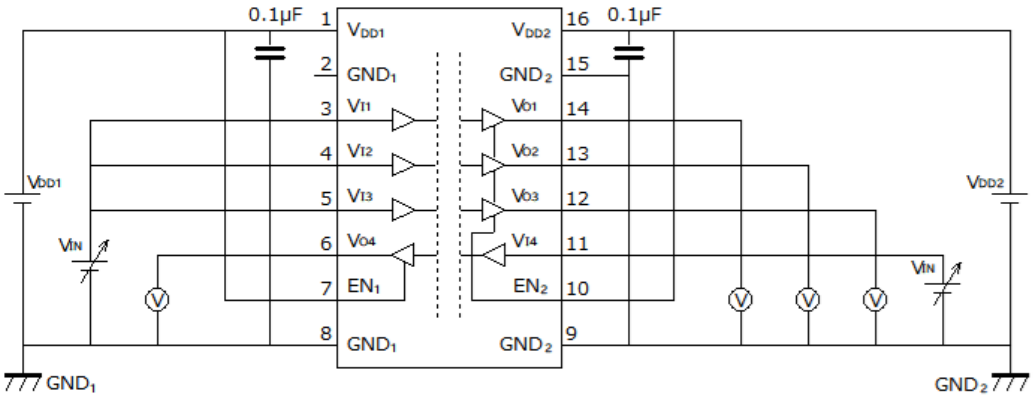


Fig.12.3.3. DCL541L01A/DCL541H01A V_{IH}/V_{IL} Test Circuit

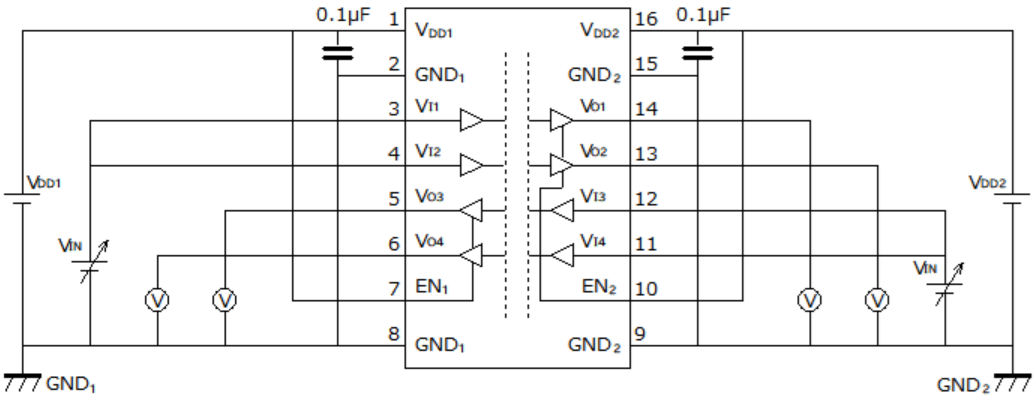


Fig.12.3.4. DCL542L01A/DCL541B01A V_{IH}/V_{IL} Test Circuit

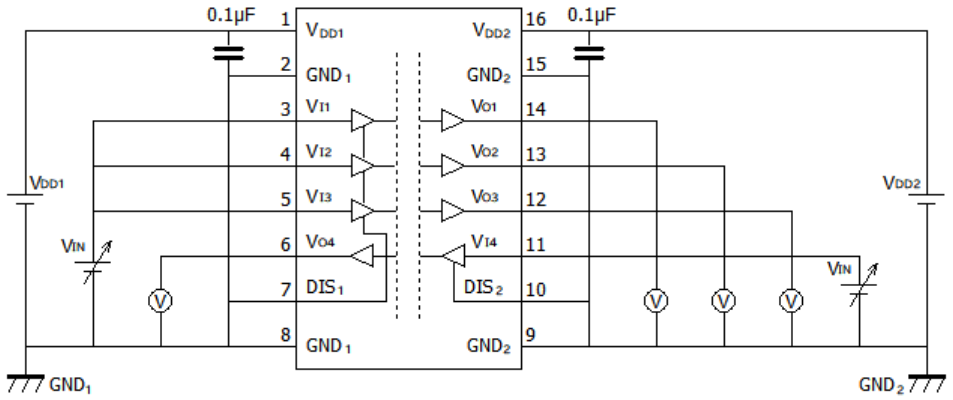
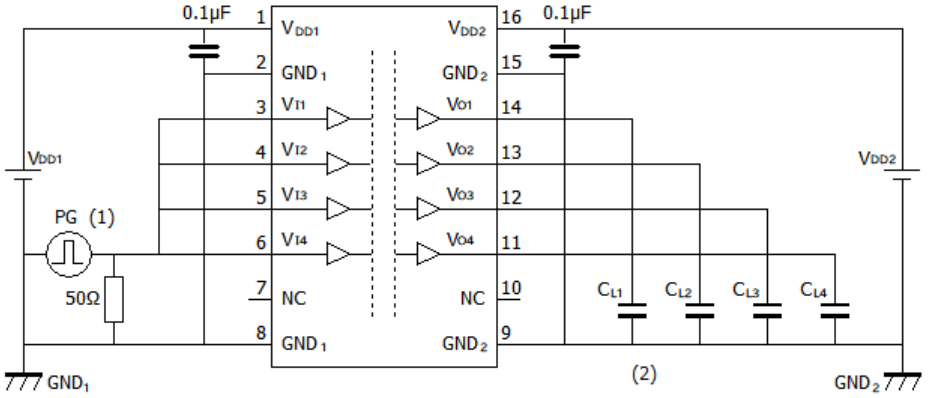
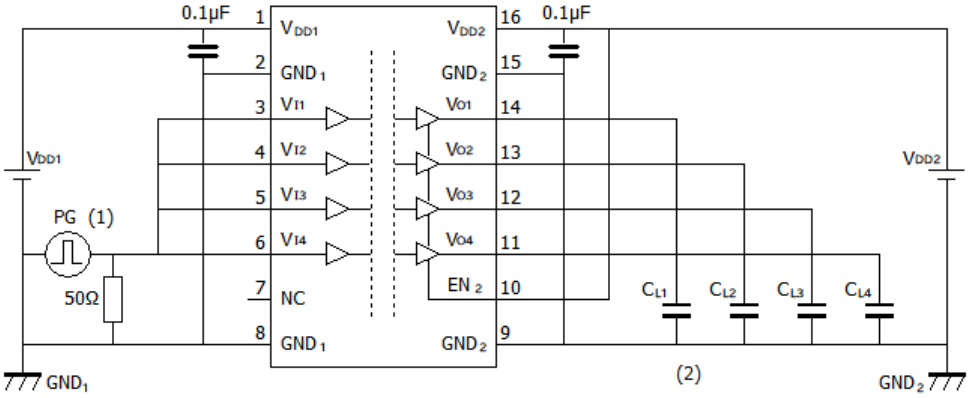


Fig.12.3.5. DCL541A01A/DCL541B01A V_{IH}/V_{IL} Test Circuit



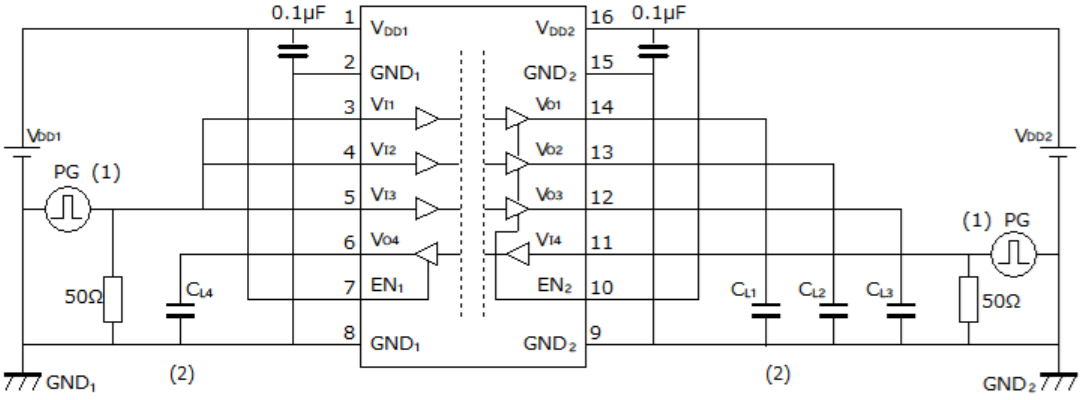
1: The input pulse is supplied by a generator having the following characteristics: PRR≤50 kHz, 50 % duty cycle, tr≤2 ns, tf≤2 ns, Z_O =50 Ω. At the input, 50 Ω resistor is required to terminate input generator signal. It is needed not in actual application.
2: C_{LX}=15 pF includes instrumentation and fixture capacitance.

Fig.12.4.1. DCL540C01A/DCL540D01A Switching Test Circuit



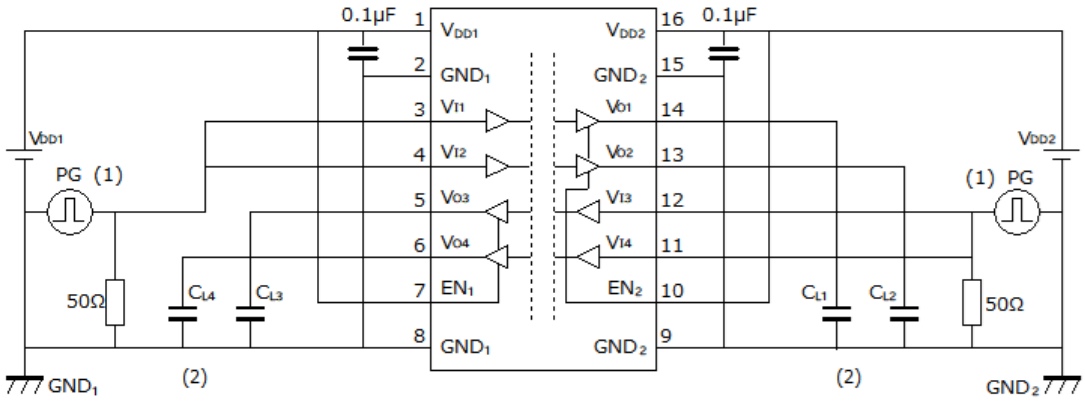
1: The input pulse is supplied by a generator having the following characteristics: PRR≤50 kHz, 50 % duty cycle, tr≤2 ns, tf≤2 ns, Z_O =50 Ω. At the input, 50 Ω resistor is required to terminate input generator signal. It is needed not in actual application.
2: C_{LX}=15 pF includes instrumentation and fixture capacitance.

Fig.12.4.2. DCL540L01A/DCL540H01A Switching Test Circuit



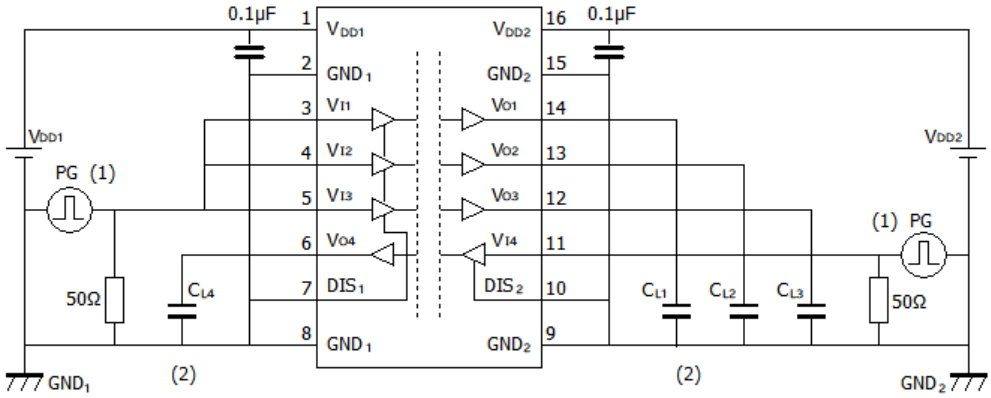
1: The input pulse is supplied by a generator having the following characteristics: PRR≤50 kHz, 50 % duty cycle, tr≤2 ns, tf≤2 ns, Z_O =50 Ω. At the input, 50 Ω resistor is required to terminate input generator signal. It is needed not in actual application.
2: C_{LX}=15 pF includes instrumentation and fixture capacitance.

Fig.12.4.3. DCL541L01A/DCL541H01A Switching Test Circuit



1: The input pulse is supplied by a generator having the following characteristics: PRR≤50 kHz, 50 % duty cycle, tr≤2 ns, tf≤2 ns, Z_O =50 Ω. At the input, 50 Ω resistor is required to terminate input generator signal. It is needed not in actual application.
2: C_{LX}=15 pF includes instrumentation and fixture capacitance.

Fig.12.4.4. DCL542L01A/DCL542H01A Switching Test Circuit



1: The input pulse is supplied by a generator having the following characteristics: PRR≤50 kHz, 50 % duty cycle, tr≤2 ns, tf≤2 ns, Z_O =50 Ω. At the input, 50 Ω resistor is required to terminate input generator signal. It is needed not in actual application.
2: C_{LX}=15 pF includes instrumentation and fixture capacitance.

Fig.12.4.5. DCL541A01A/DCL541B01A Switching Test Circuit

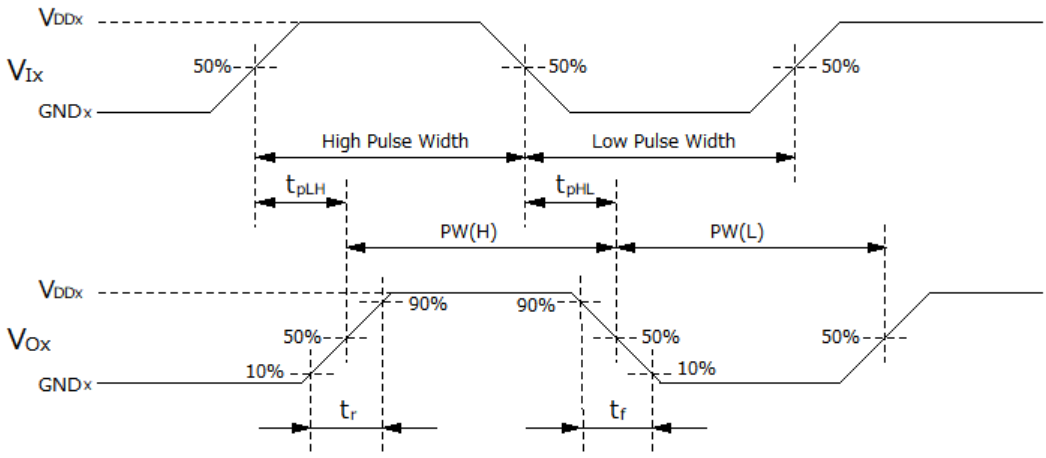
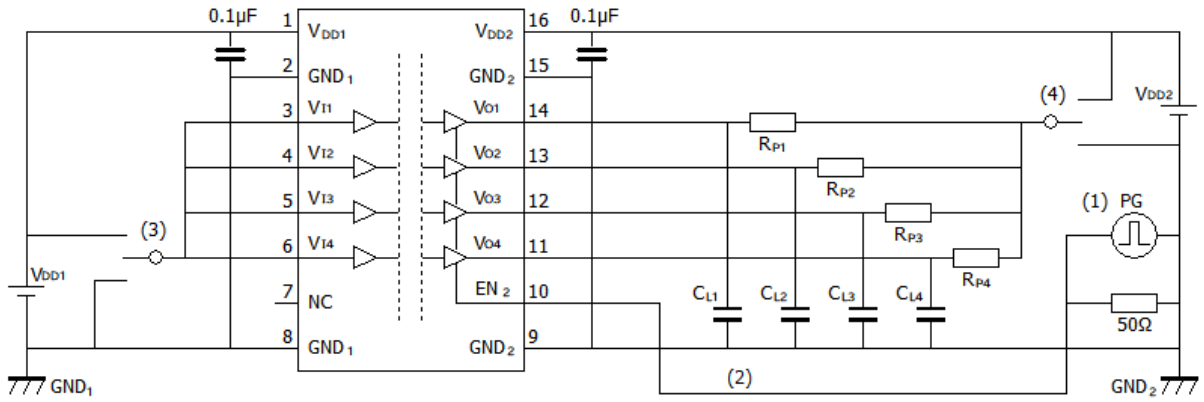
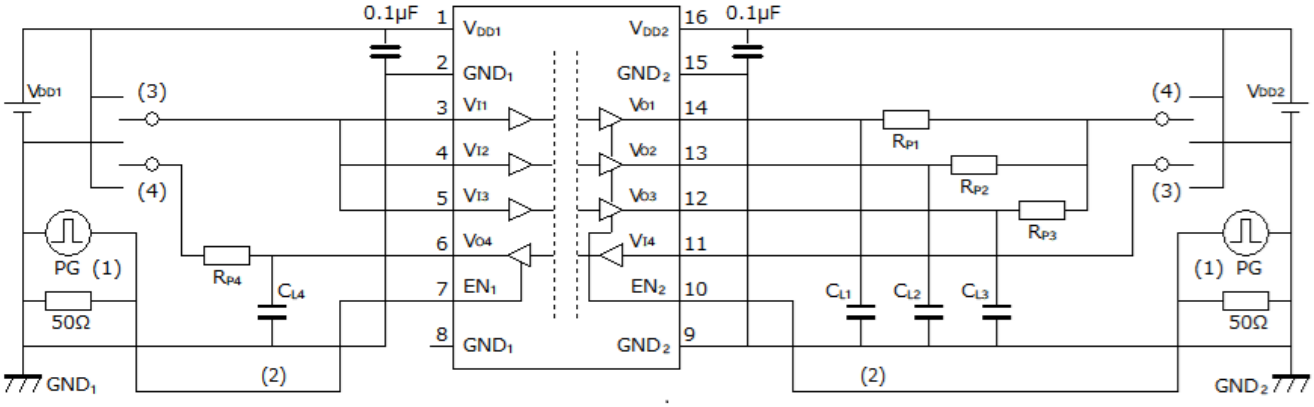


Fig.12.4.6. DCL5xxA01A Switching characteristic waveform diagram



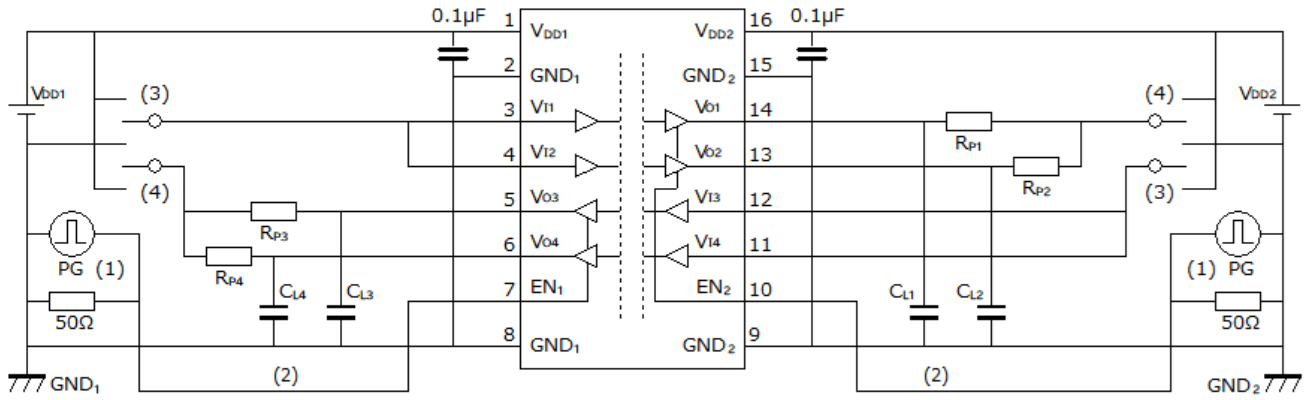
1: The input pulse is supplied by a generator having the following characteristics: PRR≤50 kHz, 50 % duty cycle, tr≤2 ns, tf≤2 ns, Z_O =50 Ω. At the input, 50 Ω resistor is required to terminate input generator signal. It is needed not in actual application.
2: C_{LX}=15 pF includes instrumentation and fixture capacitance.
3: GND for t_{pZL}, t_{pLZ}, V_{DD} for t_{pZH}, t_{pHZ}
4: V_{DD} for t_{pZL}, t_{pLZ}, GND for t_{pZH}, t_{pHZ}.

Fig.12.5.1. DCL540L01A/ DCL540H01A Enable Propagation Delay Time Test Circuit



1: The input pulse is supplied by a generator having the following characteristics: PRR≤50 kHz, 50 % duty cycle, tr≤2 ns, tf≤2 ns, Z_O =50 Ω. At the input, 50 Ω resistor is required to terminate input generator signal. It is needed not in actual application.
2: C_{LX}=15 pF includes instrumentation and fixture capacitance.
3: GND for t_{pZL}, t_{pLZ}, V_{DD} for t_{pZH}, t_{pHZ}
4: V_{DD} for t_{pZL}, t_{pLZ}, GND for t_{pZH}, t_{pHZ}.

Fig.12.5.2. DCL541L01A/ DCL541H01A Enable Propagation Delay Time Test Circuit



1: The input pulse is supplied by a generator having the following characteristics: PRR≤50 kHz, 50 % duty cycle, tr≤2 ns, tf≤2 ns, Z_O =50 Ω. At the input, 50 Ω resistor is required to terminate input generator signal. It is needed not in actual application.
2: C_{LX}=15 pF includes instrumentation and fixture capacitance.
3: GND for t_{pZL}, t_{pLZ}, V_{DD} for t_{pZH}, t_{pHZ}
4: V_{DD} for t_{pZL}, t_{pLZ}, GND for t_{pZH}, t_{pHZ}.

Fig.12.5.3. DCL542L01A/ DCL542H01A Enable Propagation Delay Time Test Circuit

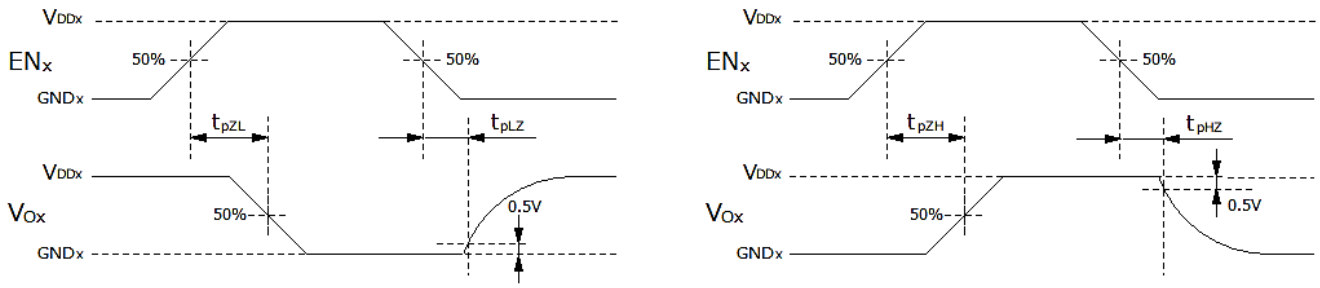
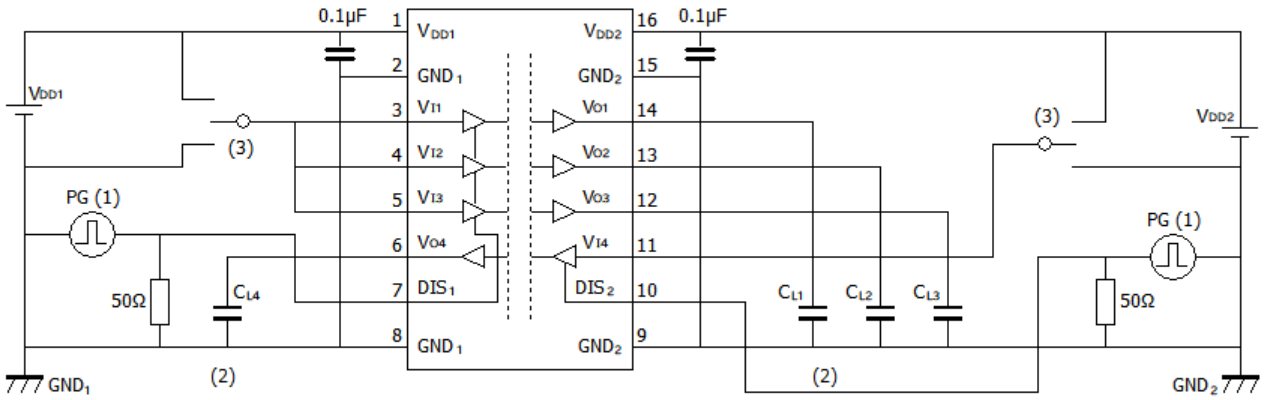


Fig.12.5.4. DCL54xL01A/ DCL54xH01A Enable propagation delay time waveform



1: The input pulse is supplied by a generator having the following characteristics: PRR≤50 kHz, 50 % duty cycle, tr≤2 ns, tf≤2 ns, Z_O =50 Ω. At the input, 50 Ω resistor is required to terminate input generator signal. It is needed not in actual application.

2: C_{LX}=15 pF includes instrumentation and fixture capacitance.

3: GND for DCL541B01A, V_{DD} for DCL541A01A

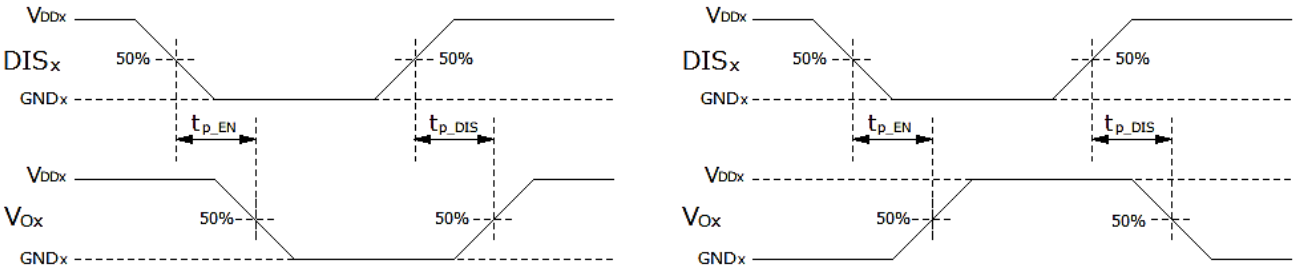
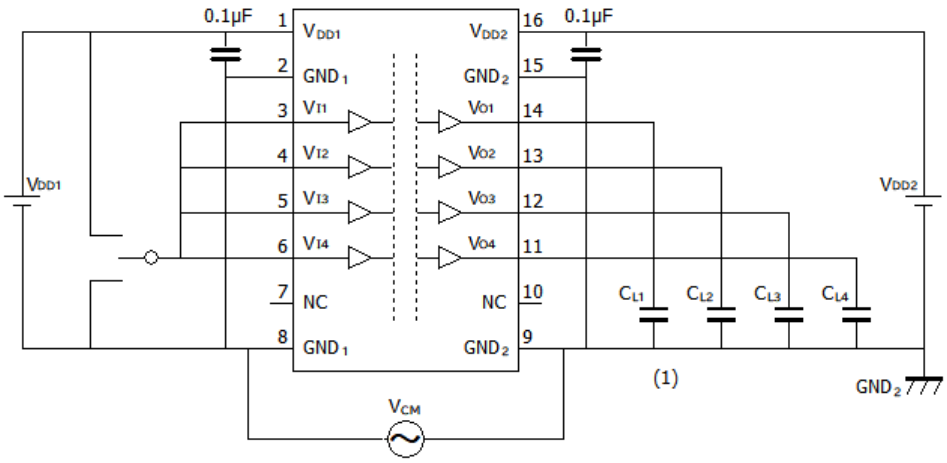


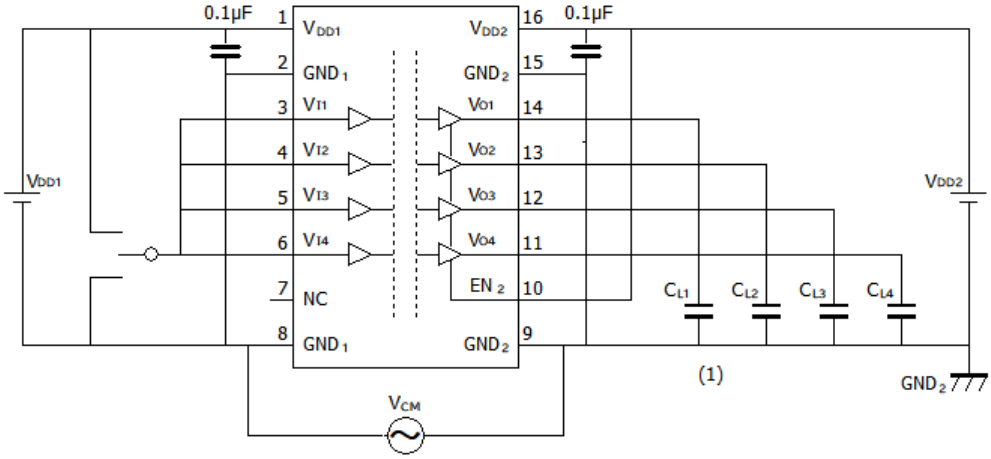
Fig.12.6. DCL541A01A/DCL541B01A Disable Propagation Delay Time Test Circuit and Waveforms



1: C_{LX}=15 pF includes instrumentation and fixture capacitance.

2: Apply V_{CM} with reference to the GND terminal on the output terminal side of the IC. The GND on the IC input terminal side is isolated from the output terminal side. Depending on which channel is being measured, V_{CM} may be applied with reference to GND_1 or with reference to GND_2.

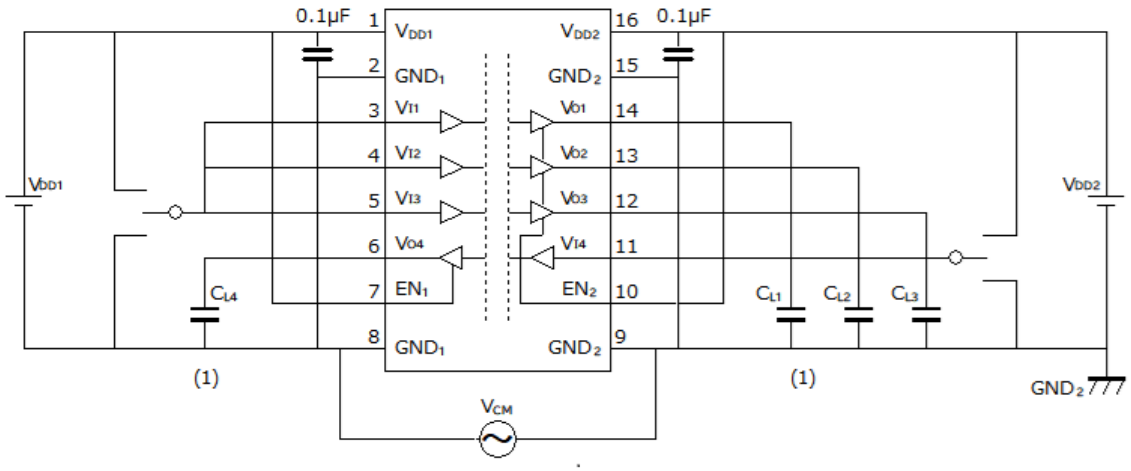
Fig.12.7.1. DCL540C01A/DCL540D01A Common-Mode Transient Immunity Test Circuit



1: C_{LX}=15 pF includes instrumentation and fixture capacitance.

2: Apply V_{CM} with reference to the GND terminal on the output terminal side of the IC. The GND on the IC input terminal side is isolated from the output terminal side. Depending on which channel is being measured, V_{CM} may be applied with reference to GND_1 or with reference to GND_2.

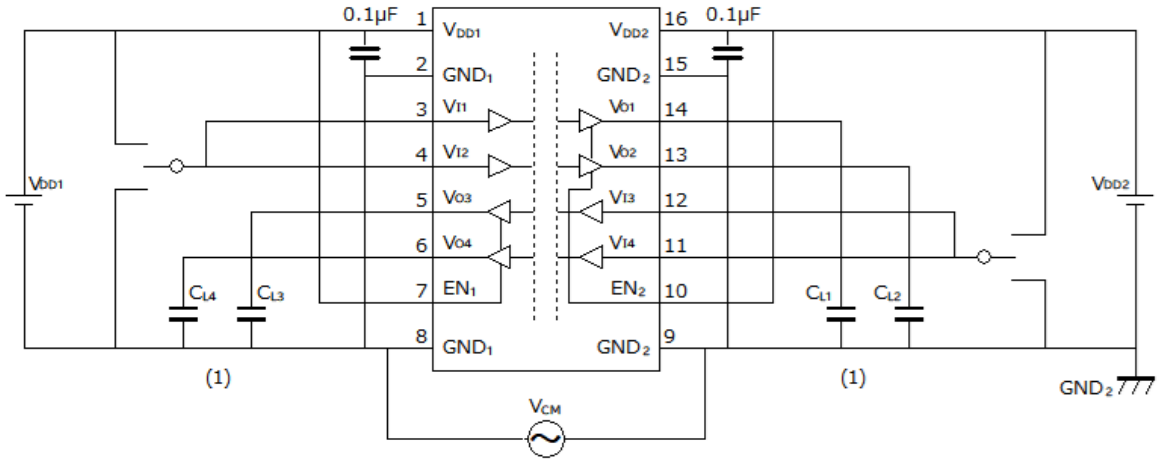
Fig.12.7.2. DCL540L01A/DCL540H01A Common-Mode Transient Immunity Test Circuit



1: C_{LX}=15 pF includes instrumentation and fixture capacitance.

2: Apply V_{CM} with reference to the GND terminal on the output terminal side of the IC. The GND on the IC input terminal side is isolated from the output terminal side. Depending on which channel is being measured, V_{CM} may be applied with reference to GND_1 or with reference to GND_2.

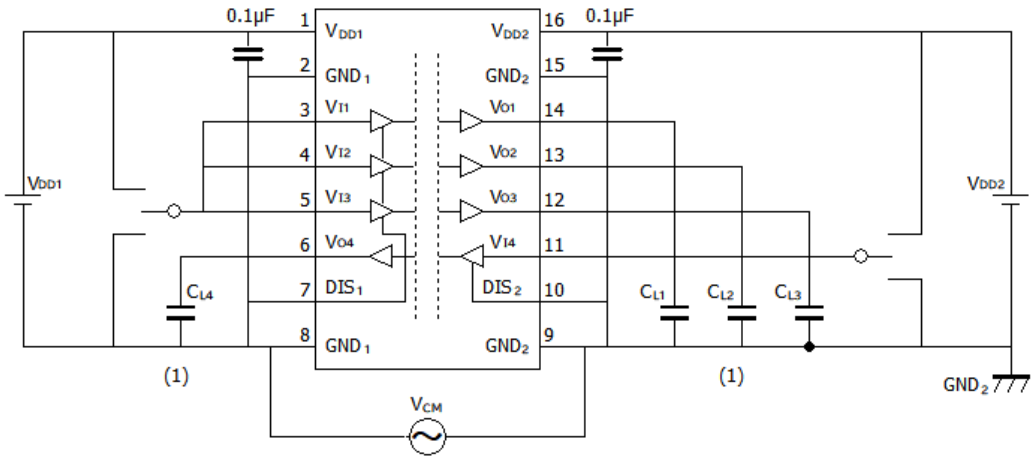
Fig.12.7.3. DCL541L01A/DCL541H01A Common-Mode Transient Immunity Test Circuit



1: C_{LX}=15 pF includes instrumentation and fixture capacitance.

2: Apply V_{CM} with reference to the GND terminal on the output terminal side of the IC. The GND on the IC input terminal side is isolated from the output terminal side. Depending on which channel is being measured, V_{CM} may be applied with reference to GND_1 or with reference to GND_2.

Fig.12.7.4. DCL542L01A/DCL542H01A Common-Mode Transient Immunity Test Circuit



1: C_{LX}=15 pF includes instrumentation and fixture capacitance.

2: Apply V_{CM} with reference to the GND terminal on the output terminal side of the IC. The GND on the IC input terminal side is isolated from the output terminal side. Depending on which channel is being measured, V_{CM} may be applied with reference to GND_1 or with reference to GND_2.

Fig.12.7.5. DCL541A01A/DCL541B01A Common-Mode Transient Immunity Test Circuit

13. Characteristics Curves (Note)

Note: The following characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

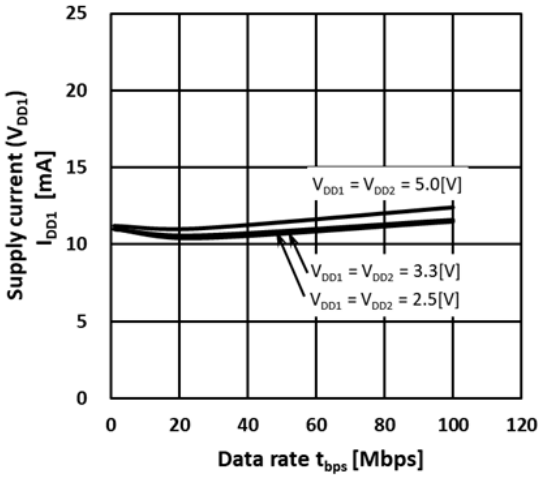


Fig.13.1. DCL540x01A I_{DD1} Supply Current - Data rate

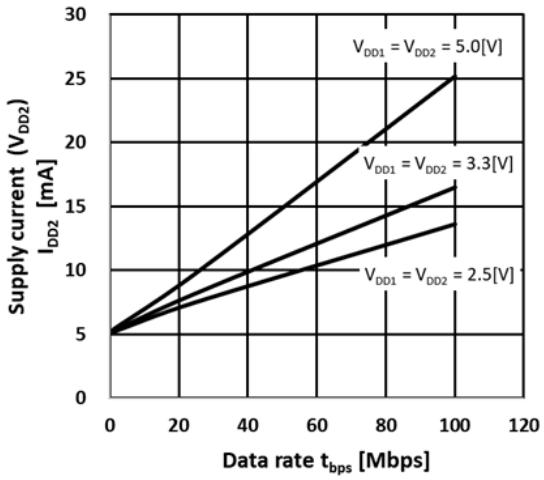


Fig.13.2. DCL540x01A I_{DD2} Supply Current - Data rate

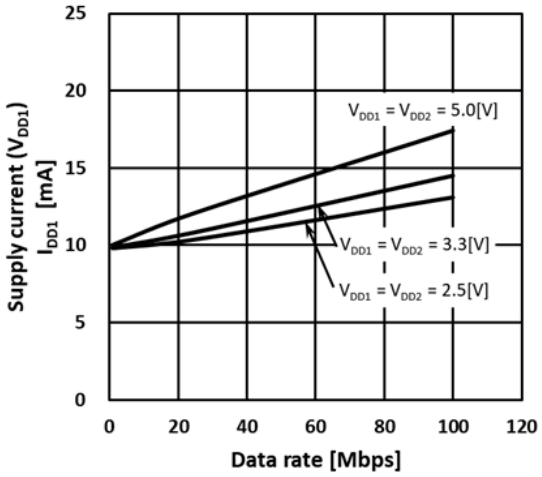


Fig.13.3. DCL541x01A I_{DD1} Supply Current - Data rate

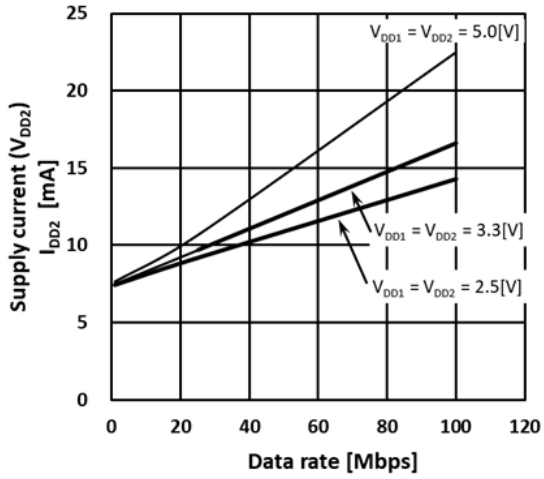


Fig.13.4. DCL5401x01A I_{DD2} Supply Current - Data rate

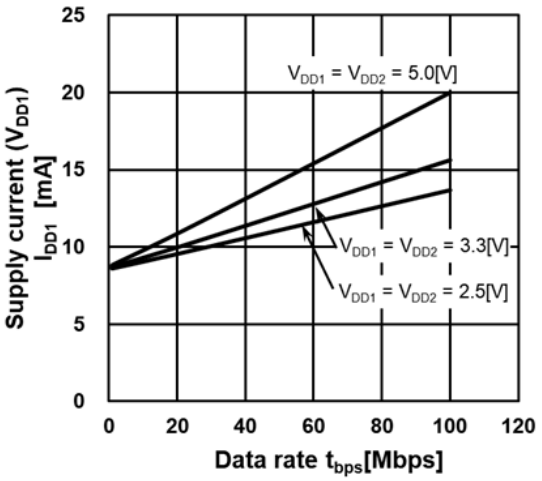


Fig.13.5. DCL542x01A I_{DD1} Supply Current - Data rate

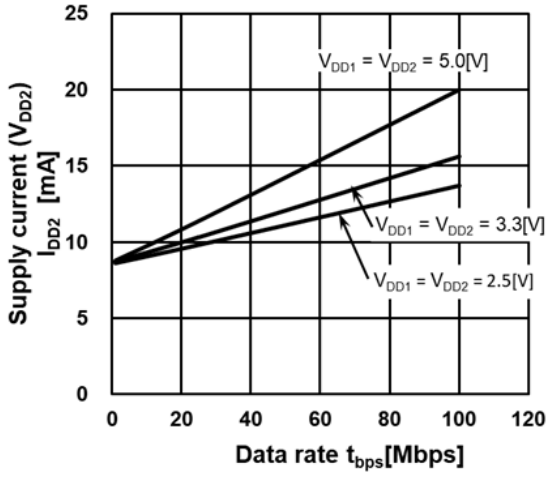


Fig.13.6. DCL542x01A I_{DD2} Supply Current - Data rate

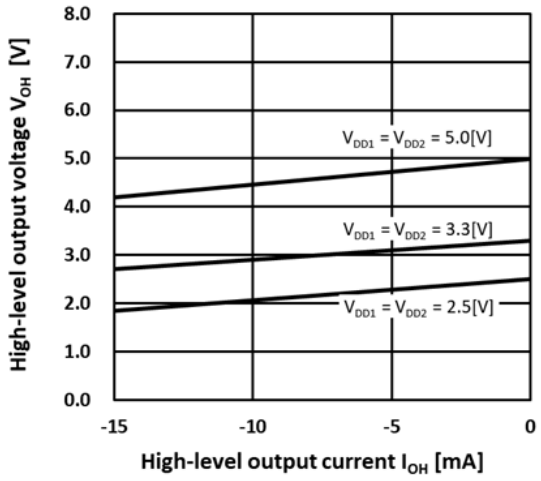


Fig.13.5. VOH - IOH

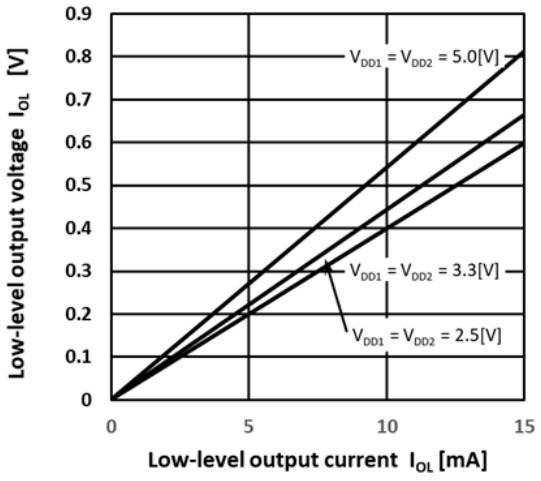


Fig.13.6. VOL – IOL

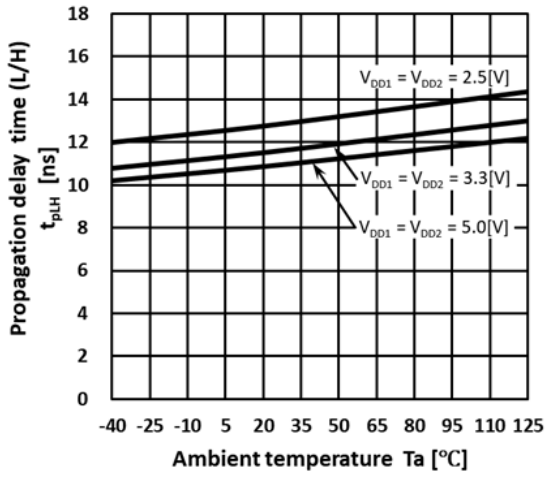


Fig.13.7. Propagation Delay Time t_{PHL} - Ta

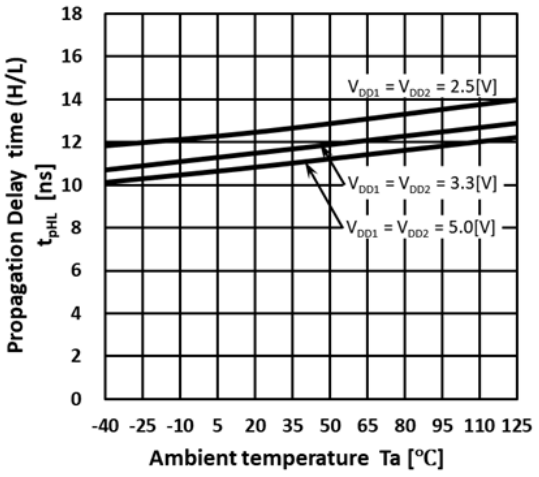


Fig.13.8. Propagation Delay Time t_{PLH} - Ta

14. Application Note

14.1. Eye diagram

The following figure shows typical eye diagrams of DCL541x01A at the maximum data rate of 150Mbps with pseudorandom bit sequences (PRBS), supply voltage 3.3 V for reference only.

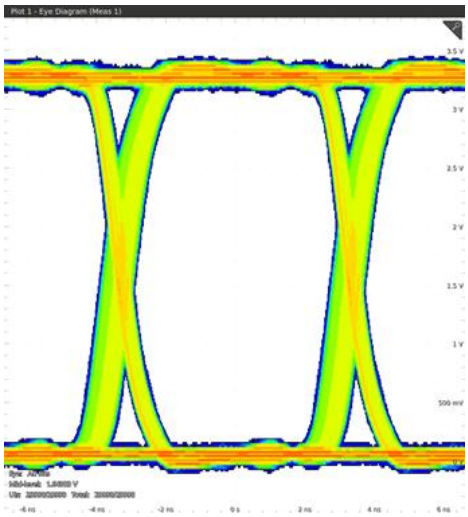


Fig.14.1 DCL541A01A Eye diagram at 150Mbps

14.2. PCB layout

A ceramic capacitor (0.1 μF) should be connected between pin 1 (V_{DD1}) and pin 2 (GND_1) for V_{DD1} and between pin 16 (V_{DD2}) and pin 15 (GND_2) for V_{DD2}, and it should be the layout on the IC as close as possible (less than 10mm). Otherwise, the IC may not operate properly.

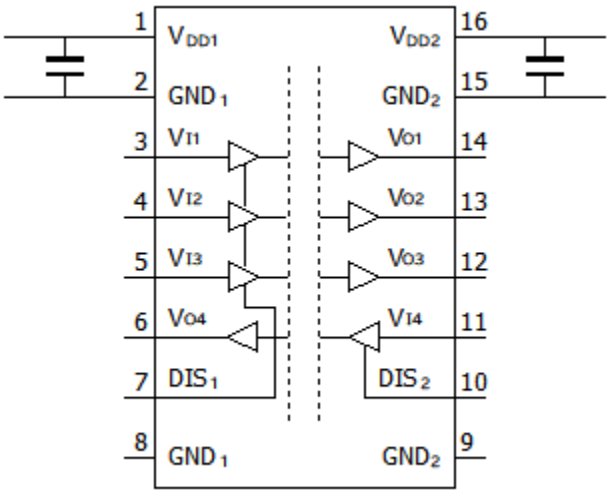
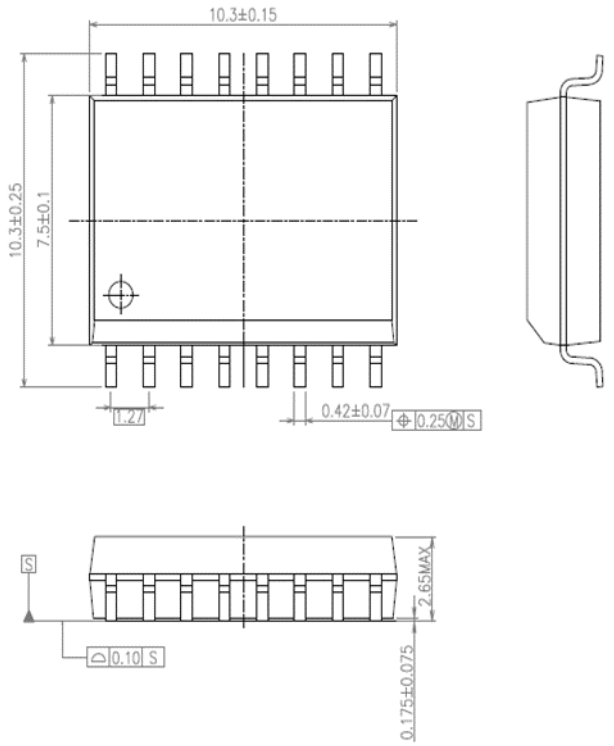
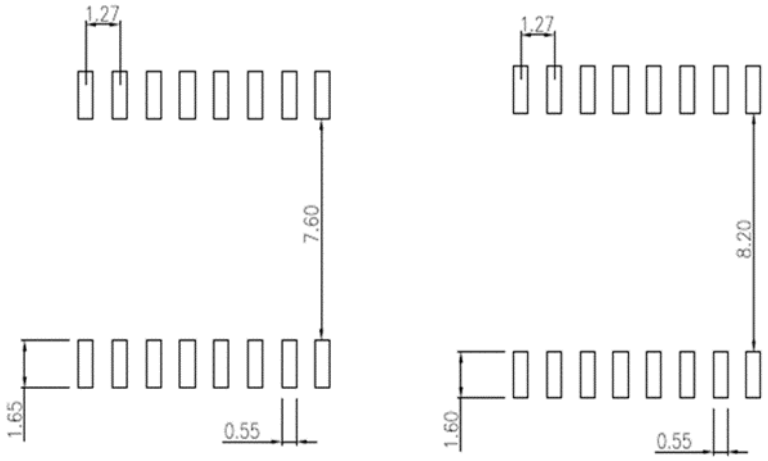


Fig.14.2 Recommended Printed Circuit Board Layout

15. Package Information

Implementation category	Surface Mount
Pin Number	16
Weight (g)	0.426 (Typical)
Package Dimension Width × Length × Height (mm)	10.3 × 10.3 × 2.65 (Max)
Package Dimension(mm) / Land Pattern Example (mm)	Package Dimension  Land Pattern Dimensions (for reference only)  Normal Option (Primary-Secondary Gap: Large)

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